



UNIVERSITÉ
Clermont
Auvergne



MEASUREMENT OF THE TOP YUKAWA COUPLING WITH THE ATLAS DETECTOR AT LHC

Merve Nazlim AGARAS
Supervisor: Djamel BOUMEDIENE

JRJC, 18 Oct, 2018

Outline

- Motivation
- Signatures
- 2LSS signature
 - ▶ Selection and background
 - ▶ Background estimation
 - ▶ BDT discriminant
- Fit
- Results
- MEM on going study

Standard Model

- The Standard Model (SM) of particle interactions describes the structure of ordinary matter and the fundamental interactions of nature
 - ▶ Re-normalisable, Lorentz inv QFT build upon local gauge symmetries of the Lagrangian
- The internal symmetries of the symmetry group

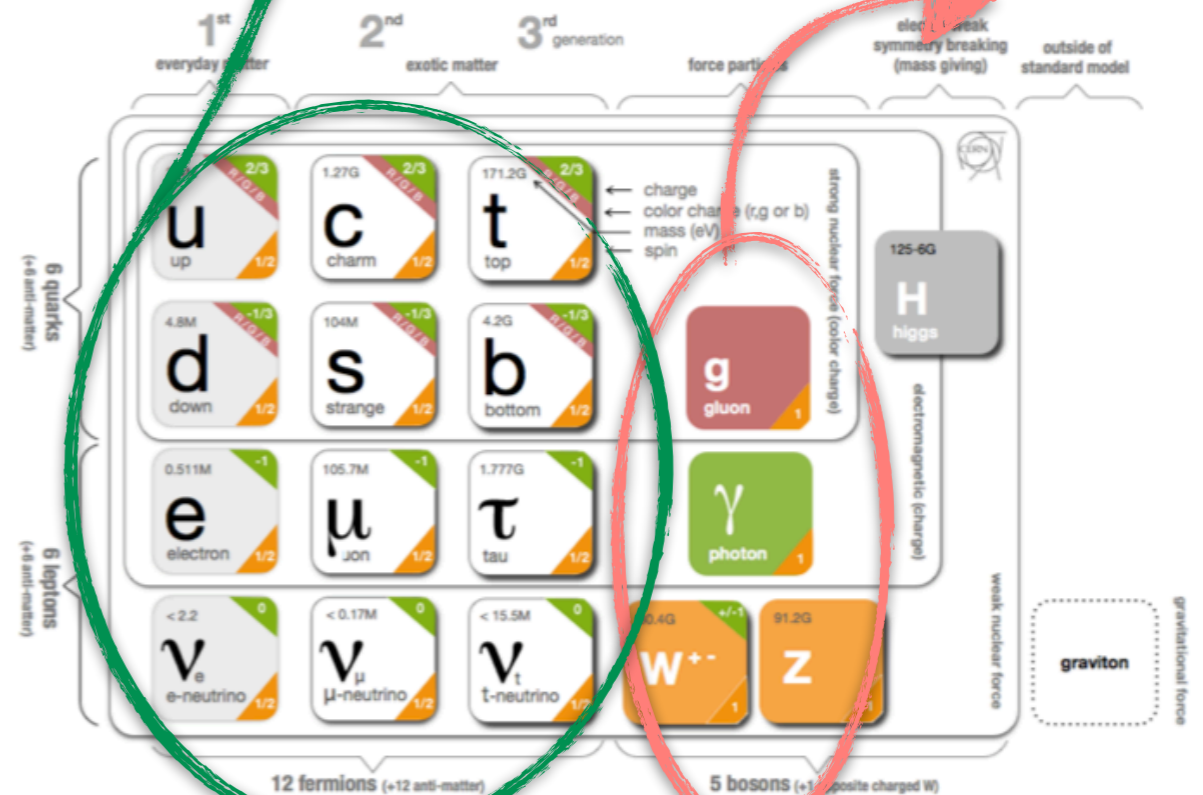
$$SU(3)_C \times SU(2)_L \times U(1)_Y$$

Strong inter.
QCD

The unified
electromagnetic and
weak interactions

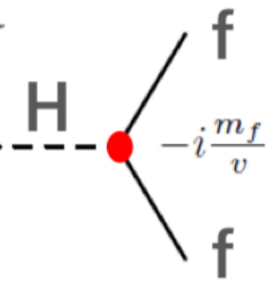
Fundamental particles;
quark & leptons

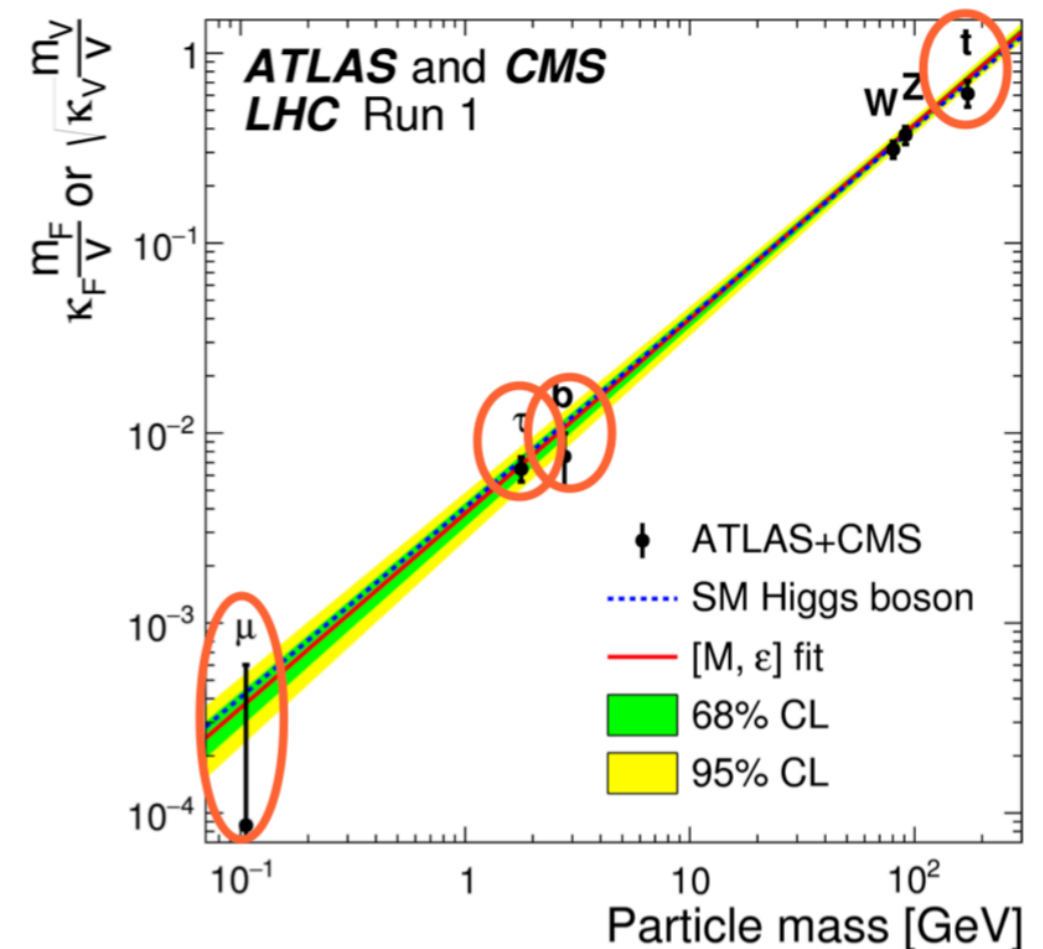
Interactions →
exchange of Gauge
bosons



Higgs Couplings

- To give gauge boson masses in the SM without losing gauge invariance in the weak interactions, a complex scalar field is introduced (4 dof)
- fermions can also couple to the scalar field and acquire mass in a way which preserves gauge invariance in the weak interaction
 - ▶ Yukawa interaction, describe the strength of the coupling of the fermion to the Higgs field
 - ▶ **proportional to the mass of the fermion**
 - ▶ arbitrary and can only be measured from experiments

$$\frac{g_f}{\sqrt{2}} = \frac{m_f}{v}$$




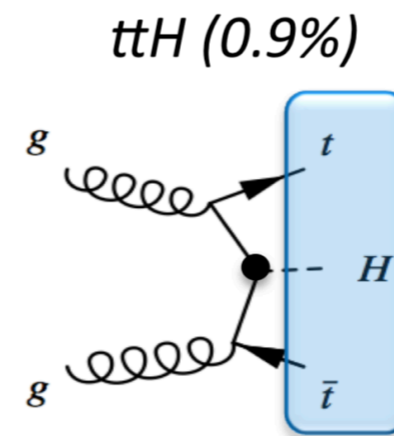
Top Yukawa Coupling at LHC

◦ Higgs-Top quark Yukawa coupling has a strong impact on the Theory, eg. Predicted Vacuum Stability or Instability depends strongly on y_t

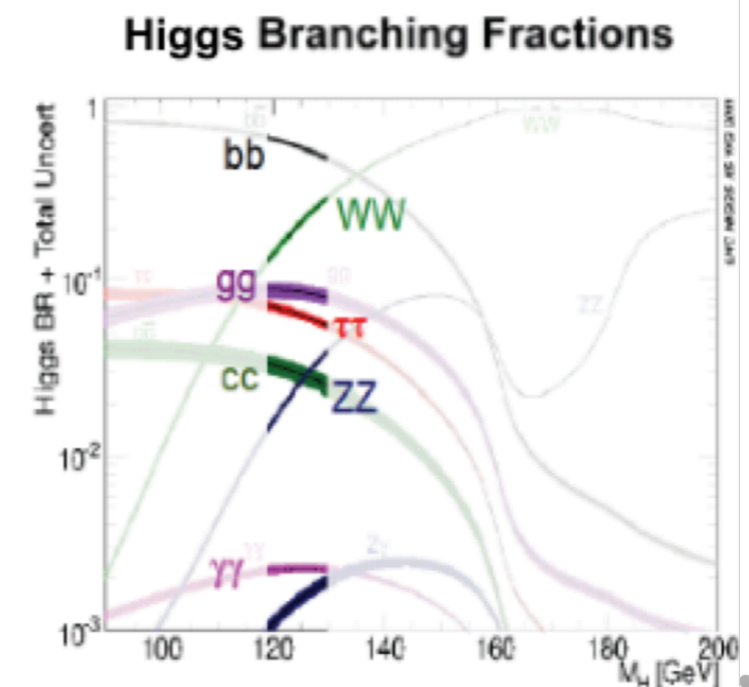
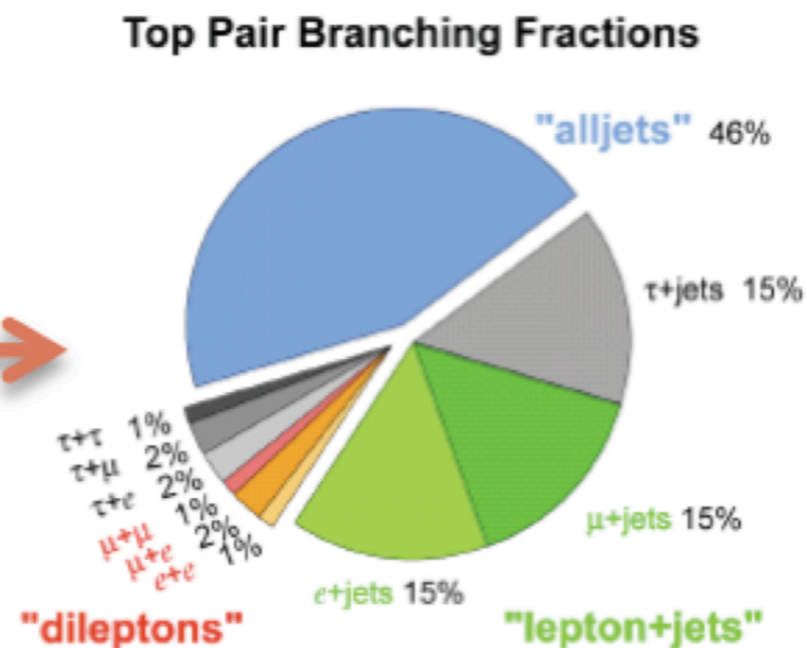
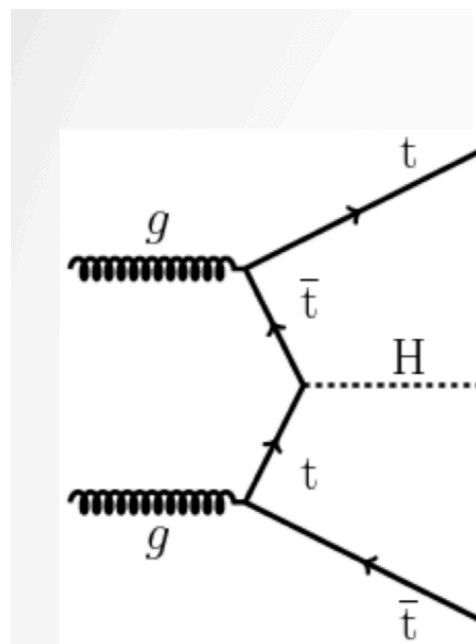
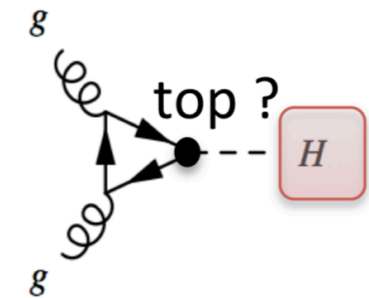
◦ Can be determined:

- ▶ Indirectly obtained through measurement of top quark mass or observed through SM Higgs decaying in two photons and production of Higgs by gluon-gluon fusion

- ▶ **Direct** measurement possible through $t\bar{t}H$ production by calculating the x-section of the process

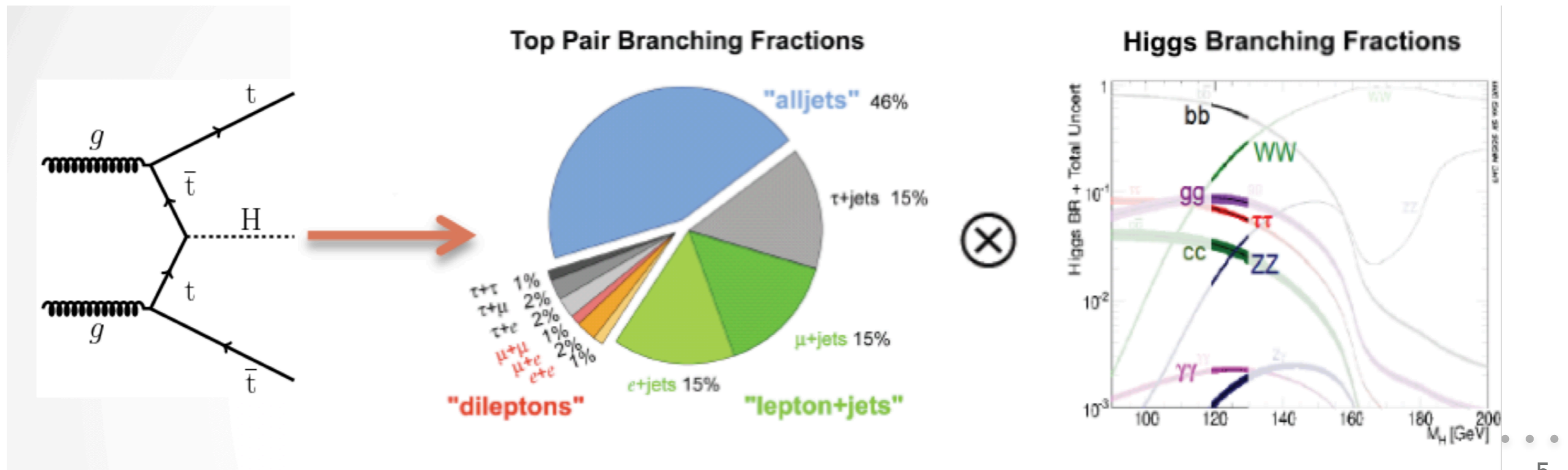


Gluon fusion (88% @13TeV pp)



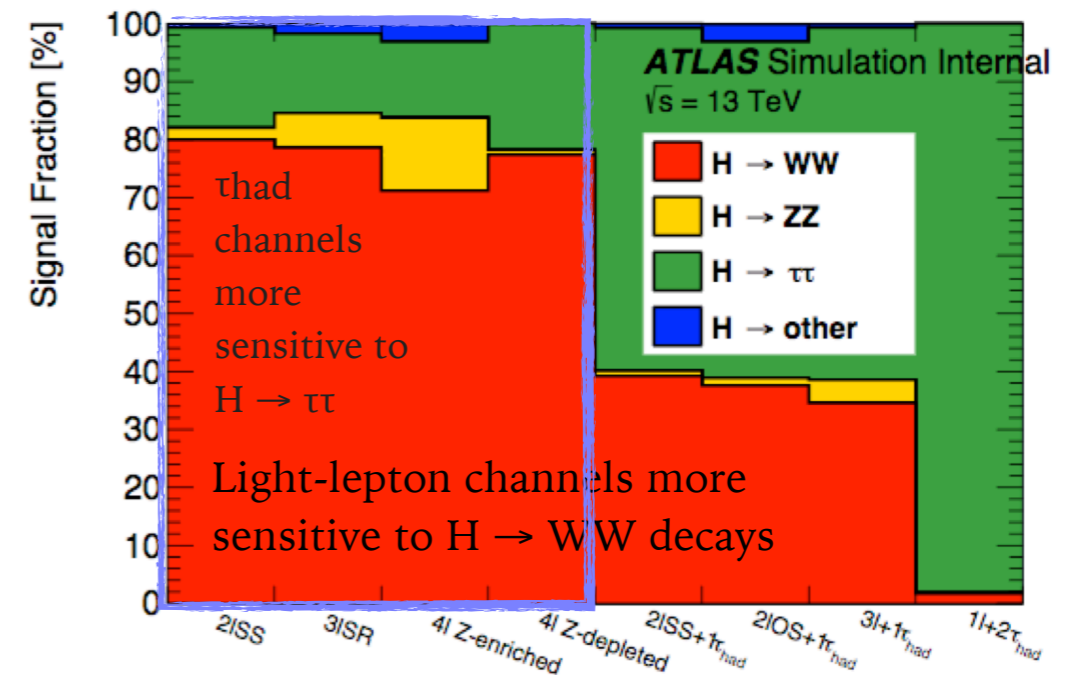
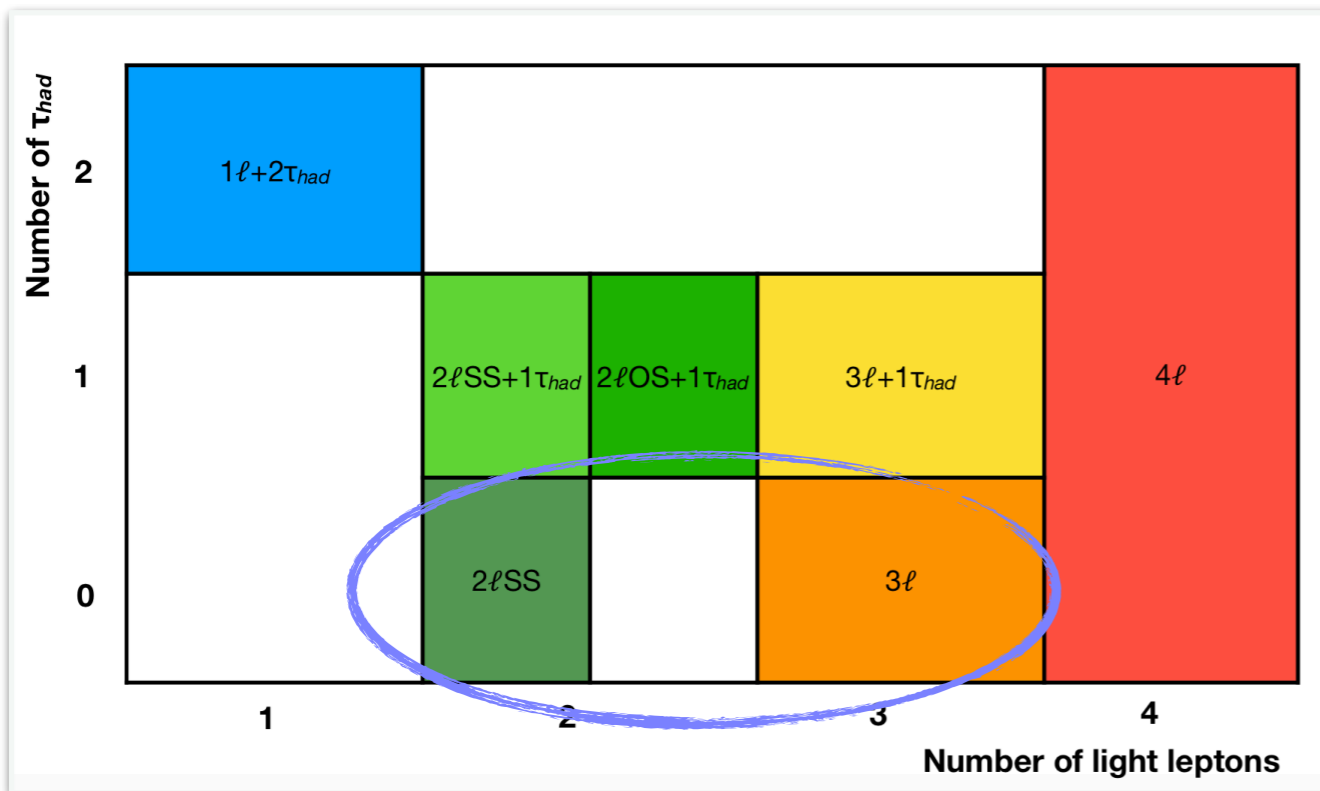
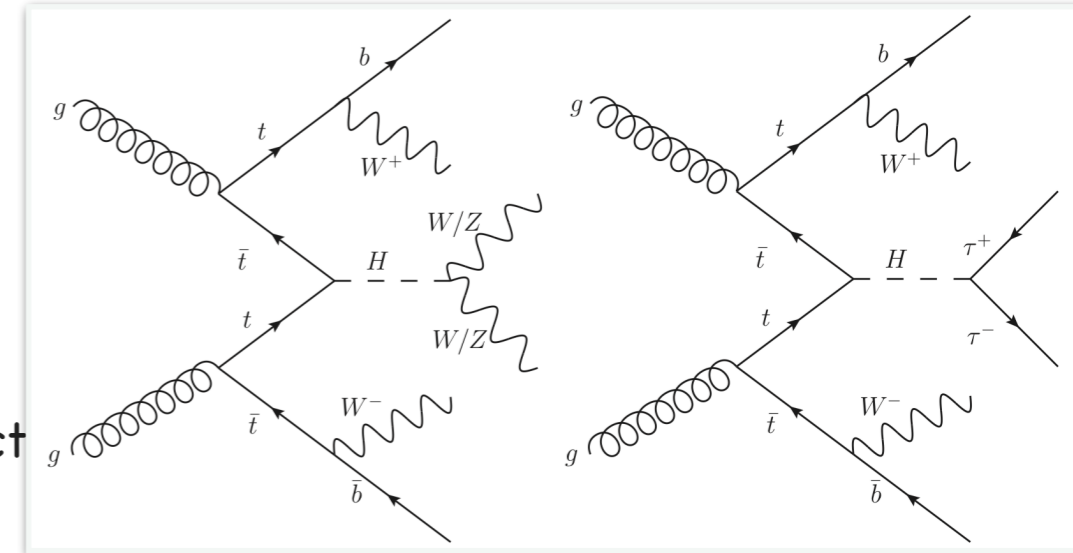
Top Yukawa Coupling at LHC

- Complex final states, with many objects: jets, b-jets, light leptons (l), hadronic taus (τ_{had}), photons
- $t\bar{t}H$ final state combines top pair decay signature and Higgs decay signature \rightarrow large number of possible final states
 - $H \rightarrow b\bar{b} : 4b + 2W \rightarrow$ Final state with largest BR from Higgs but with very large background contribution ($t\bar{t} + jets$)
 - $H \rightarrow WW, \tau\tau, ZZ : 2b + \text{multileptons} \rightarrow$ Less background contamination
 - $H \rightarrow \gamma\gamma : 2b + 2\gamma \rightarrow$ Very rare decay but very pure signal



ttH-Multilepton

- Targets Higgs decays to WW, ZZ and $\tau\tau$ with ≥ 2 (1light) lepton in their final state
- Analysis channels are defined wrt light leptons (l) and hadronic taus (τ_{had}) multiplicity (7 orthogonal channels)
- High lepton multiplicity and charge requirements are chosen to suppress backgrounds
- MVA (multivariate analysis techniques) in lepton definitions to reject fakes/non-prompt lepton
- Event classified in the different regions using MVA

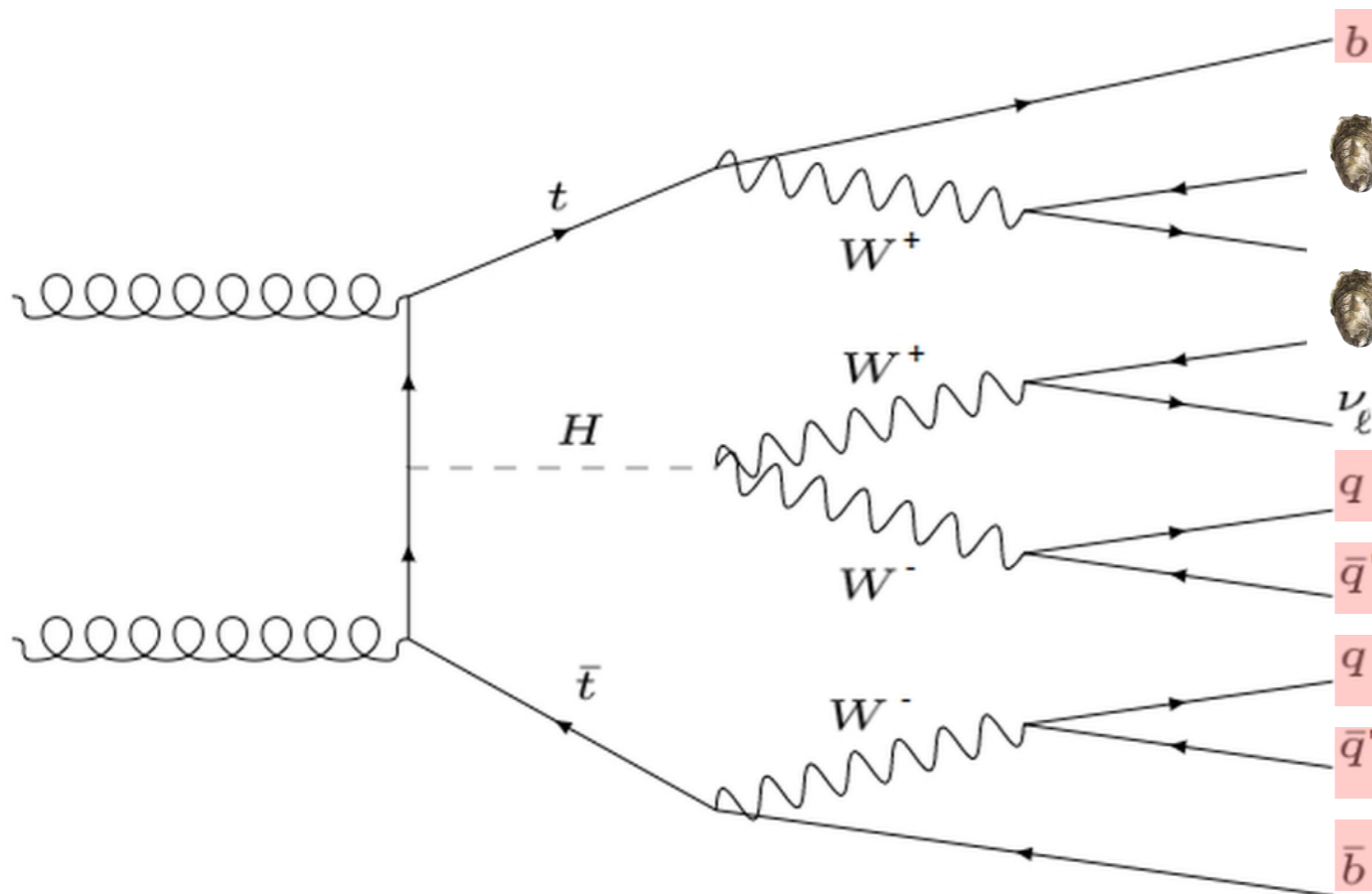


Personal Contributions

- Coordinator of productions of the reconstructed data/MC samples to the group **See backup slides..**
- Fit contact of the team
- Contributions to 2LSS analysis
 - ▶ Fakes group
 - ▶ Developing a new method to discriminate the signal from background (MEM)

2L same-sign channel

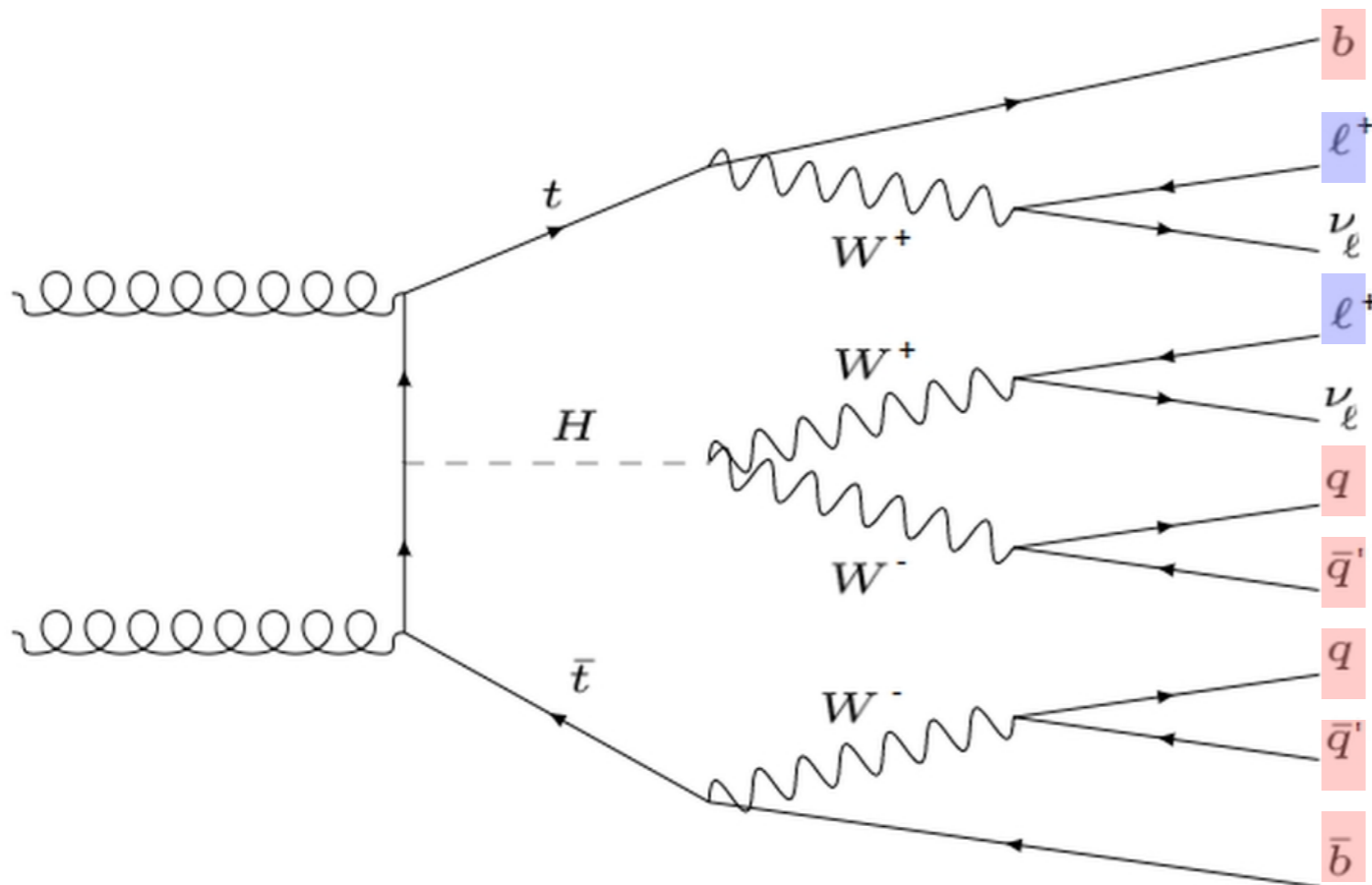
- Two reconstructed light leptons with the same electric charge
- 4 jets 2 b-jets 2 leptons



- ◆ Irreducible backgrounds:
 - ➔ From MC (with dedicated CRs)
 - ttW, ttZ, diboson
- ◆ Reducible backgrounds;
 - ➔ Data driven
 - Fake/Non-prompt leptons
 - Fake hadronic
 - Electron charge mis-identification

2L same-sign channel

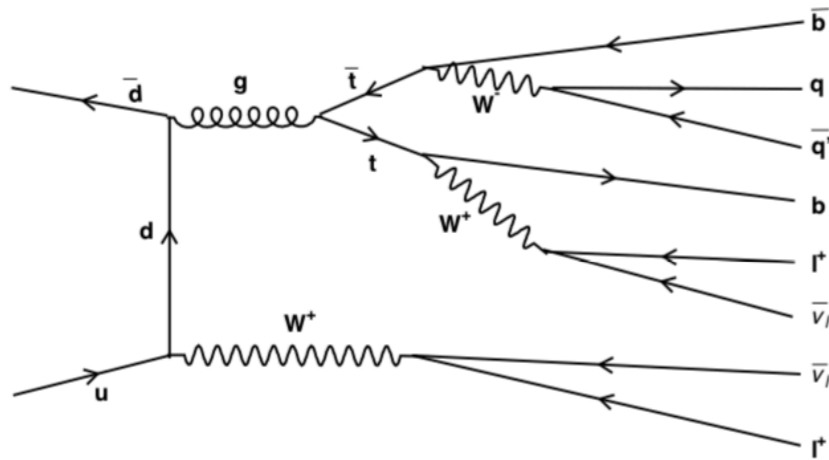
- Two reconstructed light leptons with the same electric charge
- 4 jets 2 b-jets 2 leptons



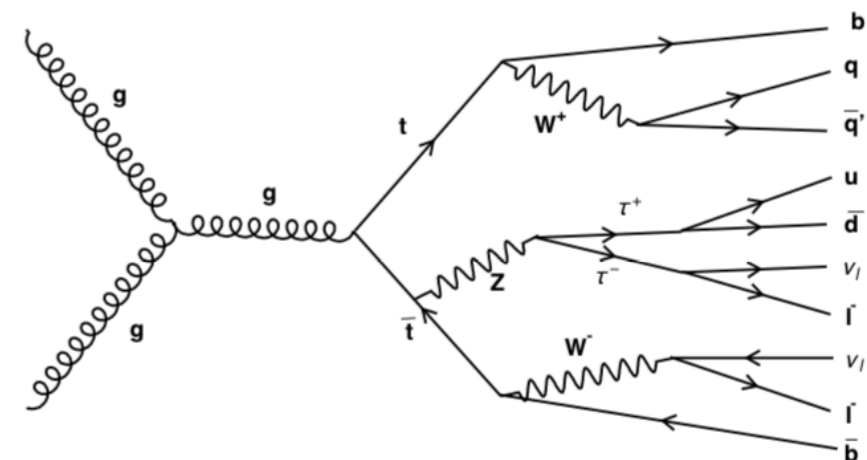
- ◆ Irreducible backgrounds:
 - ➔ From MC (with dedicated CRs)
 - ttW, ttZ, diboson
- ◆ Reducible backgrounds;
 - ➔ Data driven
 - Fake/Non-prompt leptons
 - Fake hadronic
 - Electron charge mis-identification

Irreducible Backgrounds

- Few SM processes with similar signatures
- True physical same-sign background: $t\bar{t}W$, $t\bar{t}Z$, VV estimated from MC simulation
- These background estimates are a crucial part of the analysis, because their final state and kinematics are similar to the signal



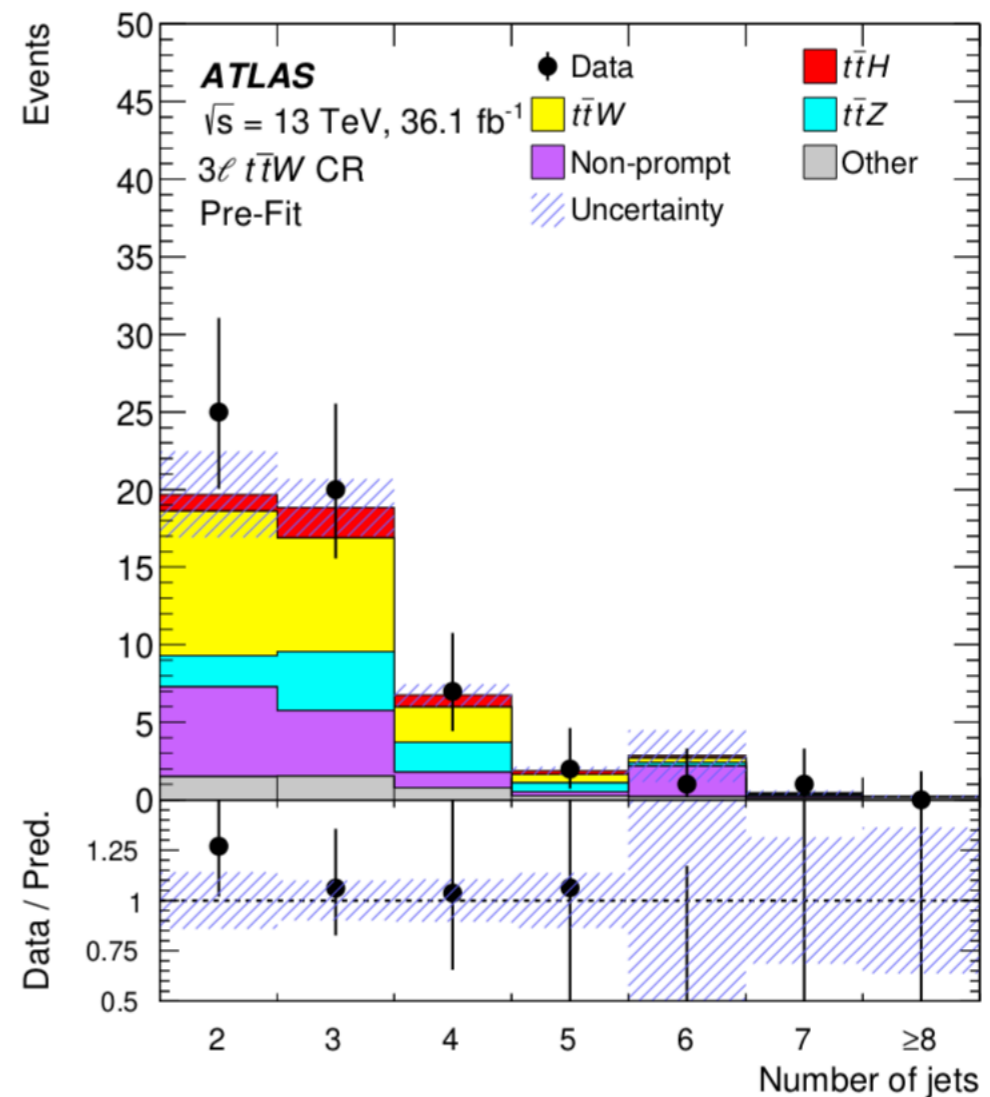
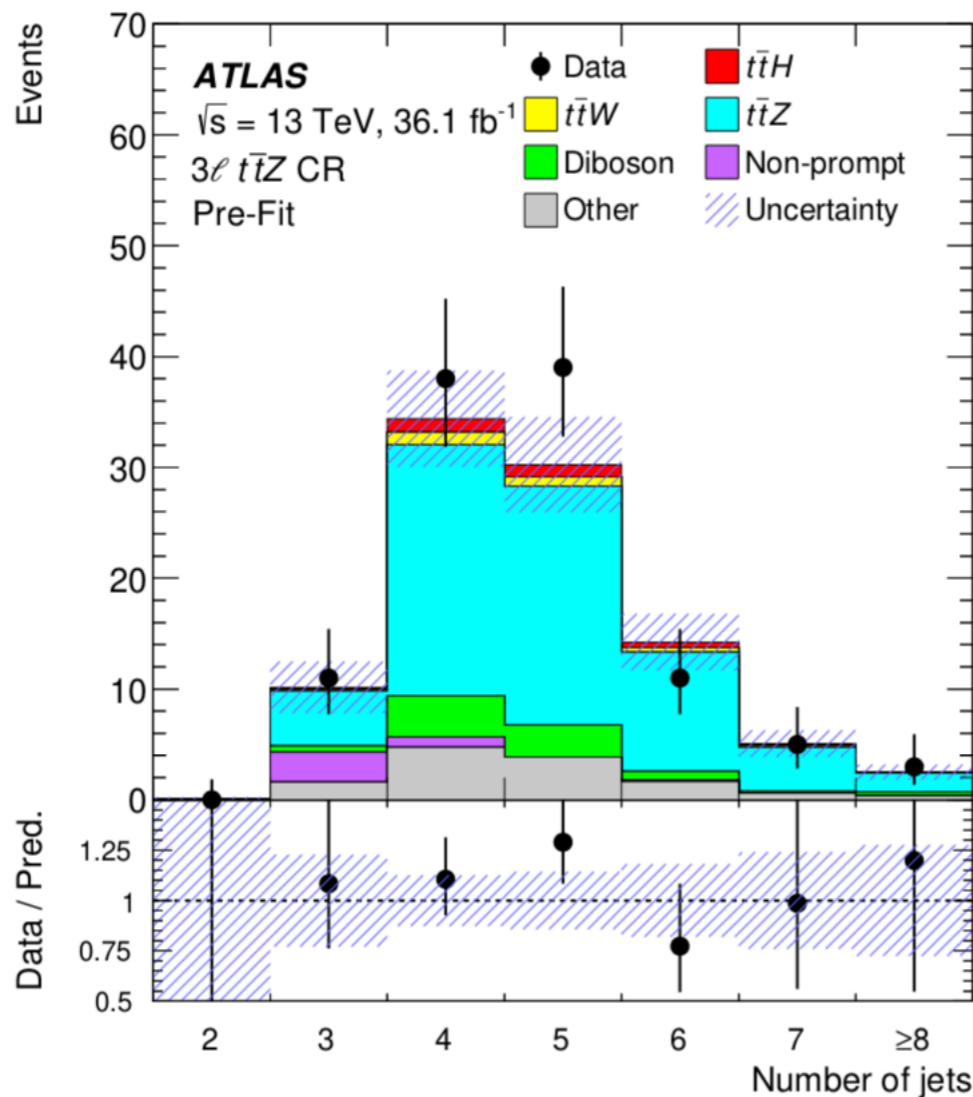
● $t\bar{t}W$ process



● $t\bar{t}Z$ process

Irreducible Backgrounds

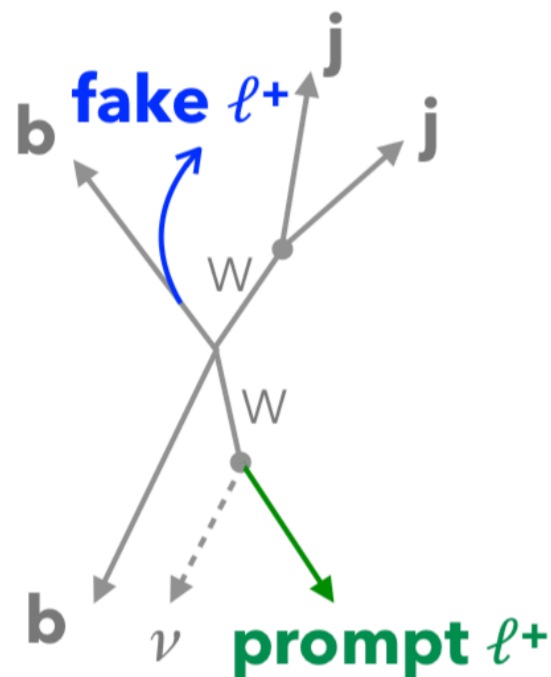
- Few SM processes with similar signatures
- True physical same-sign background: $t\bar{t}W$, $t\bar{t}Z$, VV estimated from MC simulation
- These background estimates are a crucial part of the analysis, because their final state and kinematics are similar to the signal



Reducible Backgrounds

- Data-driven methods are used to estimate the backgrounds with non-prompt light leptons, defining control regions enriched in such backgrounds and extrapolating the observed yields to the signal regions
- The non-prompt lepton background in the 2LSS channel is a mixture of leptons from semileptonic HF decays, conversions and charge mis-identification of electrons

Semileptonic
b-decay



Photon
conversions

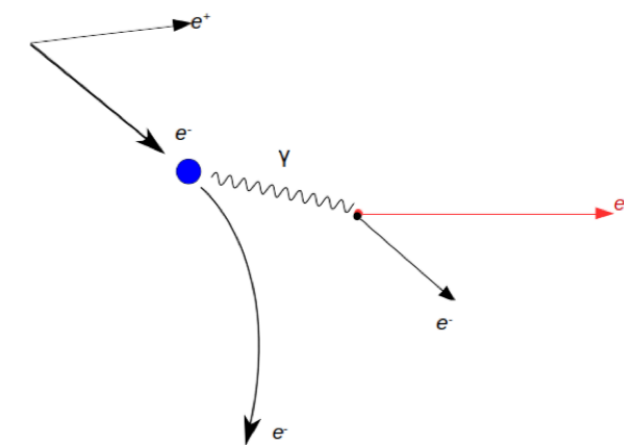
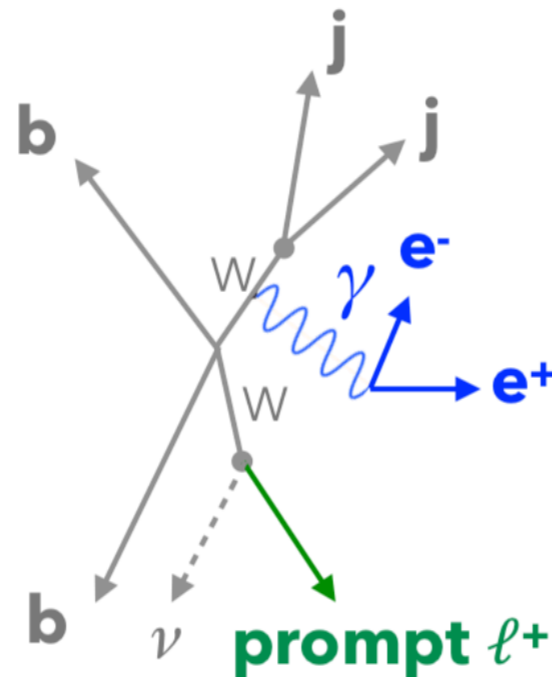
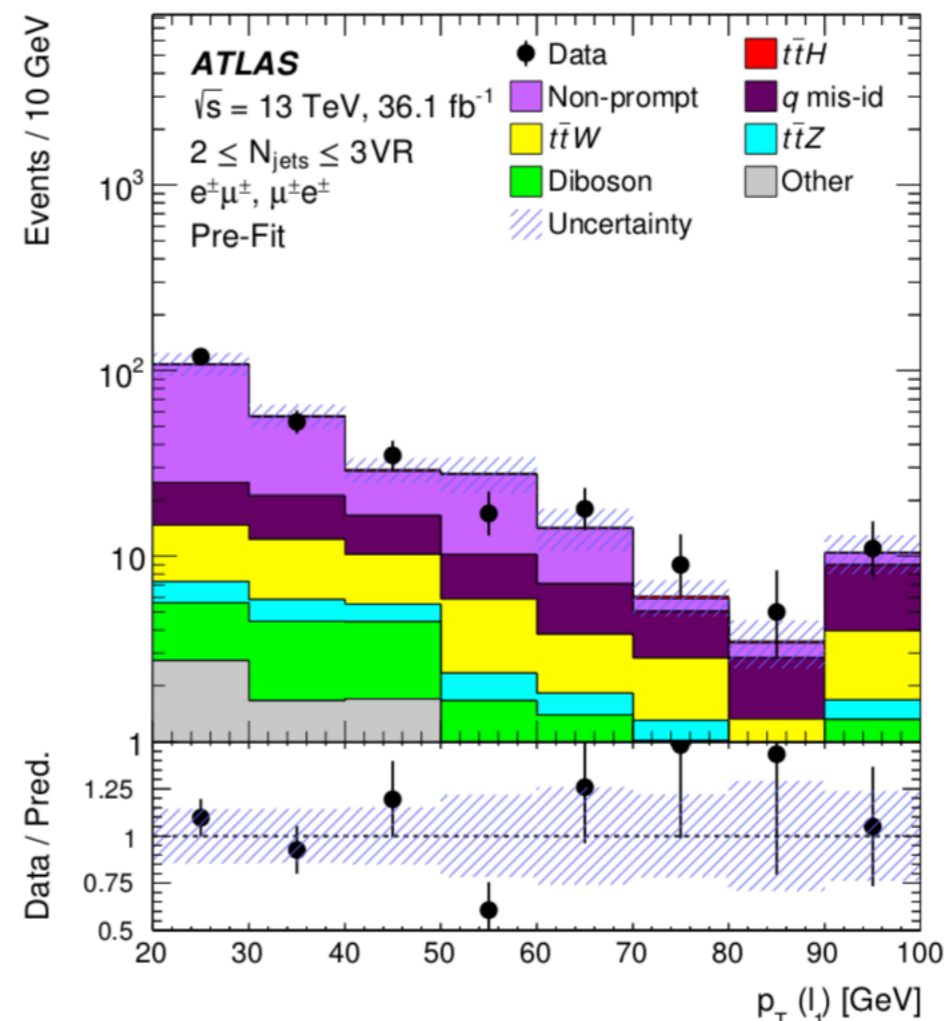
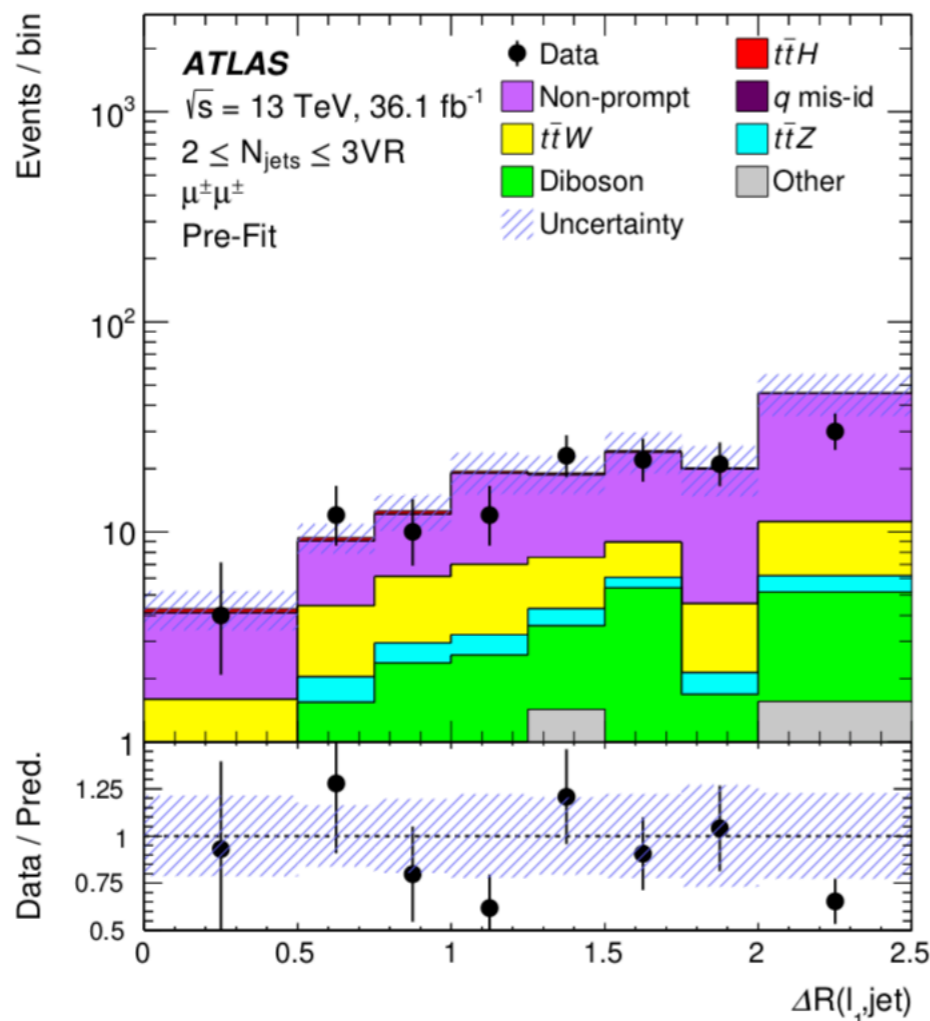


Figure: Tight electron charge-flip rates.

Reducible Backgrounds

- Data-driven methods are used to estimate the backgrounds with non-prompt light leptons, defining control regions enriched in such backgrounds and extrapolating the observed yields to the signal regions
- The non-prompt lepton background in the 2lSS channel is a mixture of leptons from semileptonic HF decays, conversions and charge mis-identification of electrons



Fake Estimates



- A data-driven method, called matrix method(MM)
- estimates the number of non-prompt leptons in the signal region
 - splitting the events in four orthogonal categories (tight/anti-tight)
- The probabilities for both the loose prompt and non-prompt leptons to be tight are measured in control regions independent from SR
- These are used to estimate the number of non-prompt events in the signal regions (at least one fake lepton)

$$\begin{pmatrix} N^{TT} \\ N^{T\bar{T}} \\ N^{\bar{T}T} \\ N^{\bar{T}\bar{T}} \end{pmatrix} = \begin{pmatrix} \epsilon_{r,1}\epsilon_{r,2} & \epsilon_{r,1}\epsilon_{f,2} & \epsilon_{f,1}\epsilon_{r,2} & \epsilon_{f,1}\epsilon_{f,2} \\ \cancel{\epsilon_{r,1}}\cancel{\epsilon_{r,2}} & \epsilon_{r,1}\cancel{\epsilon_{f,2}} & \epsilon_{f,1}\cancel{\epsilon_{r,2}} & \epsilon_{f,1}\cancel{\epsilon_{f,2}} \\ \cancel{\epsilon_{r,1}}\epsilon_{r,2} & \cancel{\epsilon_{r,1}}\epsilon_{f,2} & \cancel{\epsilon_{f,1}}\epsilon_{r,2} & \cancel{\epsilon_{f,1}}\epsilon_{f,2} \\ \cancel{\epsilon_{r,1}}\cancel{\epsilon_{r,2}} & \cancel{\epsilon_{r,1}}\cancel{\epsilon_{f,2}} & \cancel{\epsilon_{f,1}}\cancel{\epsilon_{r,2}} & \cancel{\epsilon_{f,1}}\cancel{\epsilon_{f,2}} \end{pmatrix} \begin{pmatrix} N^{rr} \\ N^{rf} \\ N^{fr} \\ N^{ff} \end{pmatrix}$$

what we want

Prompt-lepton eff. are measured as a function of p_t in CR dominated by $t\bar{t}$ bar

Fake lepton rates are measured as a function of p_T in CR corrected with the HF/Conv fraction in CR/SR from MC (aka q-scaling)

Fake Estimates

Tight

Loose

- A data-driven method, called matrix method(MM)
 - estimates the number of non-prompt leptons in the signal region
 - splitting the events in four orthogonal categories (tight/anti-tight)
- The probabilities for both the loose prompt and non-prompt leptons to be tight are measured in control regions independent from SR
- These are used to estimate the number of non-prompt events in the signal regions (at least one fake lepton)

Systematic Uncertainties

- Uncertainties of the subtracted background in the CRs
- Truth Closure
- Difference in the in the fraction of conversions from CR to SR

leptons passing the tight and loose-but-not-tight lepton selections

$$N_{TT}^f = w_{TT}N^{TT} + w_{\bar{T}T}N^{\bar{T}T} + w_{T\bar{T}}N^{T\bar{T}} + w_{\bar{T}\bar{T}}N^{\bar{T}\bar{T}}$$

Depend on the measured prompt and non-prompt lepton efficiencies

Charge mis-identification estimation

- Electron charge-flip in SS dilepton final states introduces background from OS events
- Two main mechanisms:
 - ▶ Trident process with an electron radiating a photon converting to a pair of electrons
 - ▶ Mis-reconstructed electron track in the Inner Detector. Becomes dominant at large p_T
- Rate of QMisid computed from $Z \rightarrow e^+e^-$ mass peak region and used to reweight OS data using 3D likelihood method [p_T , η , Tight/Loose]
- The contamination in the SR is estimated from the reconstructed OS data events passing SR criteria (except the SS requirement).

Likelihood:

$$L(\vec{\epsilon}) = \prod_{i=1}^{N_{bins}} \prod_{j=1}^{N_{bins}} \text{Poisson}(N_{Z,ij}^{SS}, (\epsilon_i + \epsilon_j - 2\epsilon_i \epsilon_j) \cdot N_{Z,ij}^{SS+OS})$$

where:

$$\epsilon_i \cdot (1 - \epsilon_j) + \epsilon_j \cdot (1 - \epsilon_i) = \epsilon_i + \epsilon_j - 2\epsilon_i \cdot \epsilon_j$$

is the probability that the charge of exactly one electron is mis-identified.

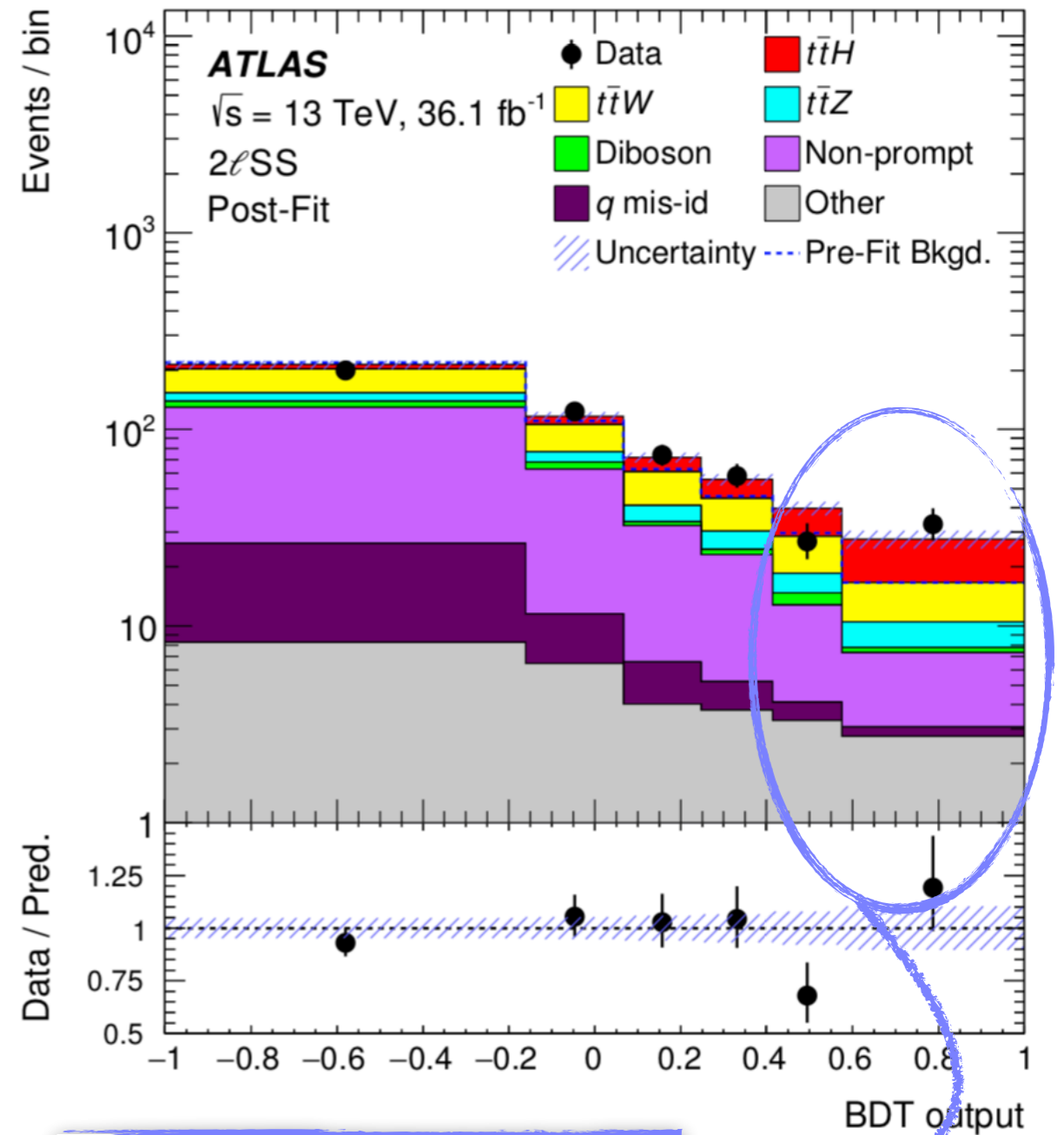
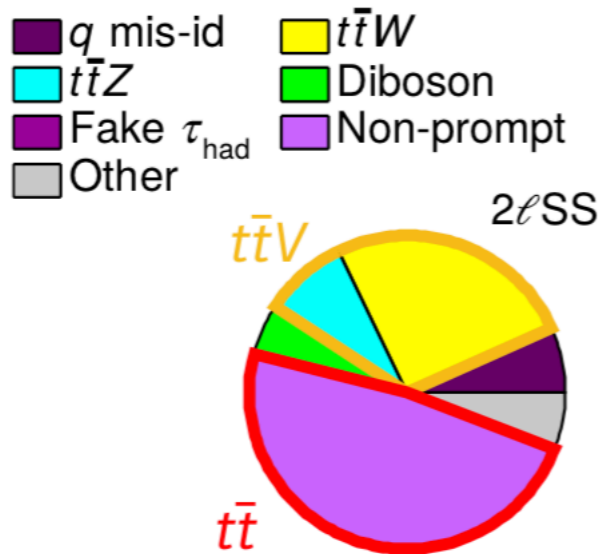
Uncertainties:

- statistical errors (LH);
- definition of Z mass window;
- truth closure;

2LSS Channel

Use two independent event BDTs $t\bar{t}H$ vs $t\bar{t}V$ vs $t\bar{t}b\bar{a}r$ with input variables (average of the two BDTs is used)

- ▶ Lepton properties
- ▶ Jet and b-tagged jet multiplies
- ▶ Angular distances
- ▶ MET



The discriminant BDTG is splitted in 6 bins
 the highest bins more pure in $t\bar{t}H$

Statistical Model

- A **maximum-likelihood** fit is performed on twelve categories (8 SR, 4 CR) simultaneously to extract the ttH signal strength (free parameter) $\mu_{ttH} = \sigma/\sigma_{SM}$
- The statistical analysis of the data uses a binned likelihood function $L(\mu, \theta)$, which is constructed from a product of Poisson probability distribution (the number of observed events in a given bin (n))

Poisson distribution in each bin

Binned Likelihood

$$L(N_S, N_B; \{n_i\}_{i=1 \dots n_{bins}}) = \prod_{i=1}^{n_{bins}} e^{-N_S s_i + N_B b_i} \frac{(N_S s_i + N_B b_i)^{n_i}}{n_i!}$$

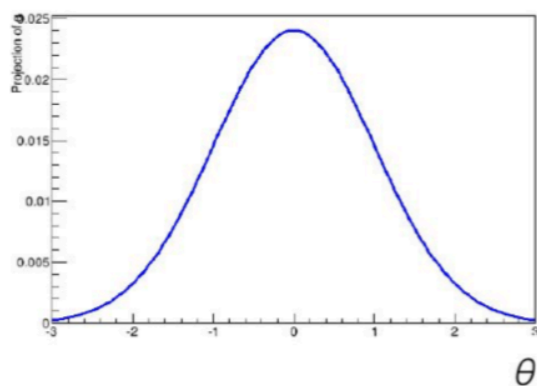
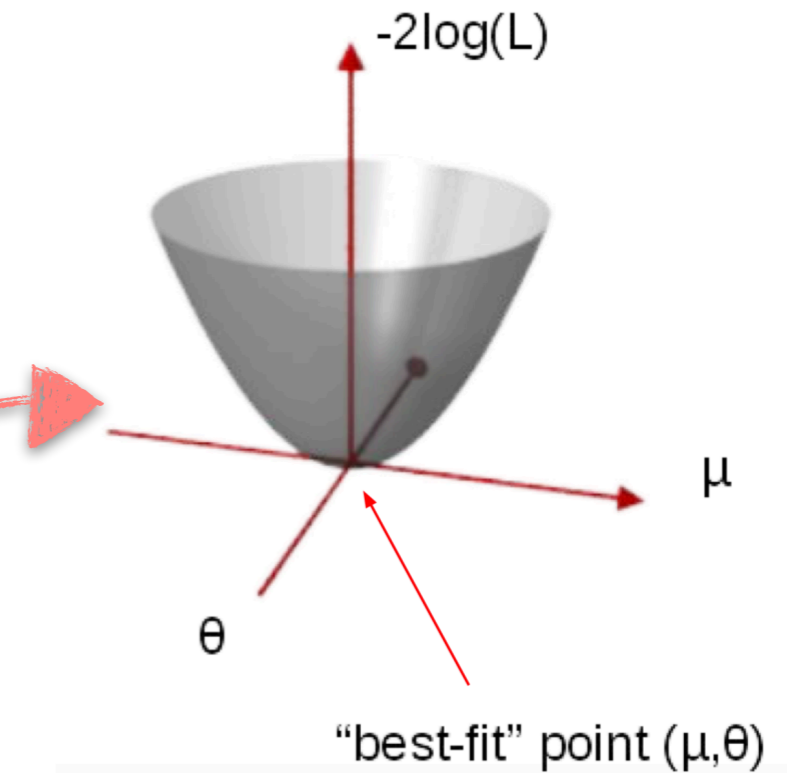
The diagram shows the equation for the binned likelihood function. A green arrow points from the text 'Signal yield' to the variable N_S . A red arrow points from the text 'Bkg yield' to the variable N_B . A blue arrow points from the text 'Observed yields per bin' to the set of variables $\{n_i\}_{i=1 \dots n_{bins}}$. A purple bracket above the fraction in the equation is labeled 'Poisson distribution in each bin'. Two purple arrows point from the text 'Per-bin fractions (=shapes) for Signal and Bkg' to the terms s_i and b_i in the numerator of the fraction.

↑ **Signal yield**
↑ **Bkg yield**
↑ **Observed yields per bin**
↑ **Per-bin fractions (=shapes) for Signal and Bkg**

Systematics and Profile Likelihood

~300 NPs in the analysis

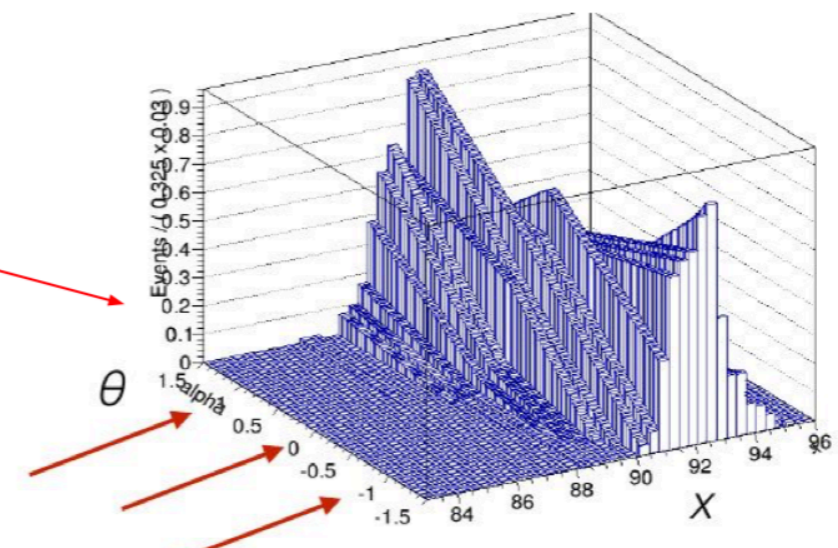
- Nuisance parameters (NPs), which encode all the uncertainties on quantities that can affect the model for signal and background
- NP probability density functions (Gaussian) are constrained by the auxiliary measurements of the parameters (unlike μ)
 - ▶ eg.
- N-dimensional likelihood maximisation (or **negative-log-likelihood minimisation**)



$$L(\mathbf{n}, \theta^0 | \mu, \theta) =$$

$$\prod_{i \in \text{bins}} P(n_i | \mu S(\theta) + B(\theta)) \times$$

$$\prod_{j \in \text{n.p.}} G(\theta_j^0 | \theta_j)$$



Testing Model

- What values to use when defining the hypotheses ? $\rightarrow H(\mu=0, \theta=?)$ **Answer:** let the data choose the best-fit values
- Significance is given by the **profile-likelihood ratio:**

Profile likelihood ratio only dependent on μ	$\lambda(\mu) = \frac{\mathcal{L}(\mu, \hat{\theta}_\mu)}{\mathcal{L}(\hat{\mu}, \hat{\theta})}$	Maximize L for a given μ 'conditional' likelihood
		Maximize L 'unconditional' likelihood

- Construct Test statistics by using effective μ (how well the observed data agrees with the background-only hypothesis)

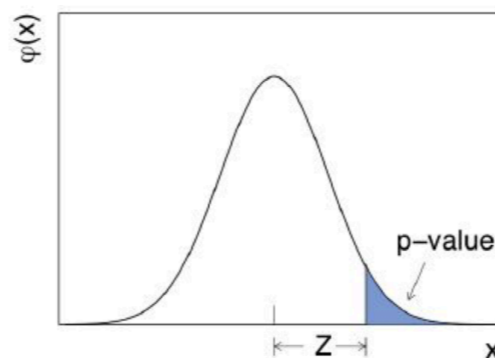
$$q_0 = \begin{cases} -2 \ln \lambda(0) & \hat{\mu} \geq 0 \\ 0 & \hat{\mu} < 0 \end{cases} \quad \text{reject background-only}$$

↑
increasing level
of incompatibility

- In particle physics, the rejection of the background-only hypothesis to claim for a discovery is conventionally achieved for a significance of $Z \geq 5$, corresponding to $p \leq 2.87 \times 10^{-7}$

$$p_0 = \int_{q_{0, \text{obs}}}^{\infty} f(q_0|0) dq_0$$

$$Z_0 = \Phi^{-1}(1 - p_0)$$



Testing Model

- What values to use when defining the hypotheses ? $\rightarrow H(\mu=0, \theta=?)$ **Answer:** let the data choose the best-fit values
- Significance is given by the **profile-likelihood ratio:**

Profile likelihood ratio only dependent on μ	$\lambda(\mu) = \frac{\mathcal{L}(\mu, \hat{\theta}_\mu)}{\mathcal{L}(\hat{\mu}, \hat{\theta})}$	Maximize L for a given μ 'conditional' likelihood
		Maximize L 'unconditional' likelihood

- Construct Test statistics by using effective μ (how well the observed data agrees with the background-only hypothesis)

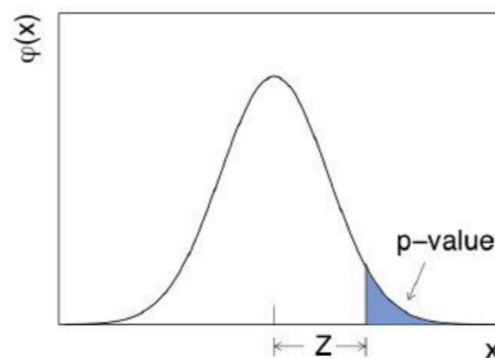
$$q_0 = \begin{cases} -2\ln\lambda(0) & \hat{\mu} \geq 0 \\ 0 & \hat{\mu} < 0 \end{cases} \quad \text{reject background-only}$$

↑ increasing level
of incompatibility

- In particle physics, the rejection of the background-only hypothesis to claim for a discovery is conventionally achieved for a significance of $Z \geq 5$, corresponding to $p \leq 2.87 \times 10^{-7}$

$$p_0 = \int_{q_{0,obs}}^{\infty} f(q_0|0) dq_0$$

$$Z_0 = \Phi^{-1}(1 - p_0)$$



the sampling distribution for our test statistic—
>**Wilks' Theorem:** PLR also follows a χ^2 !

Pull/Impact Plot

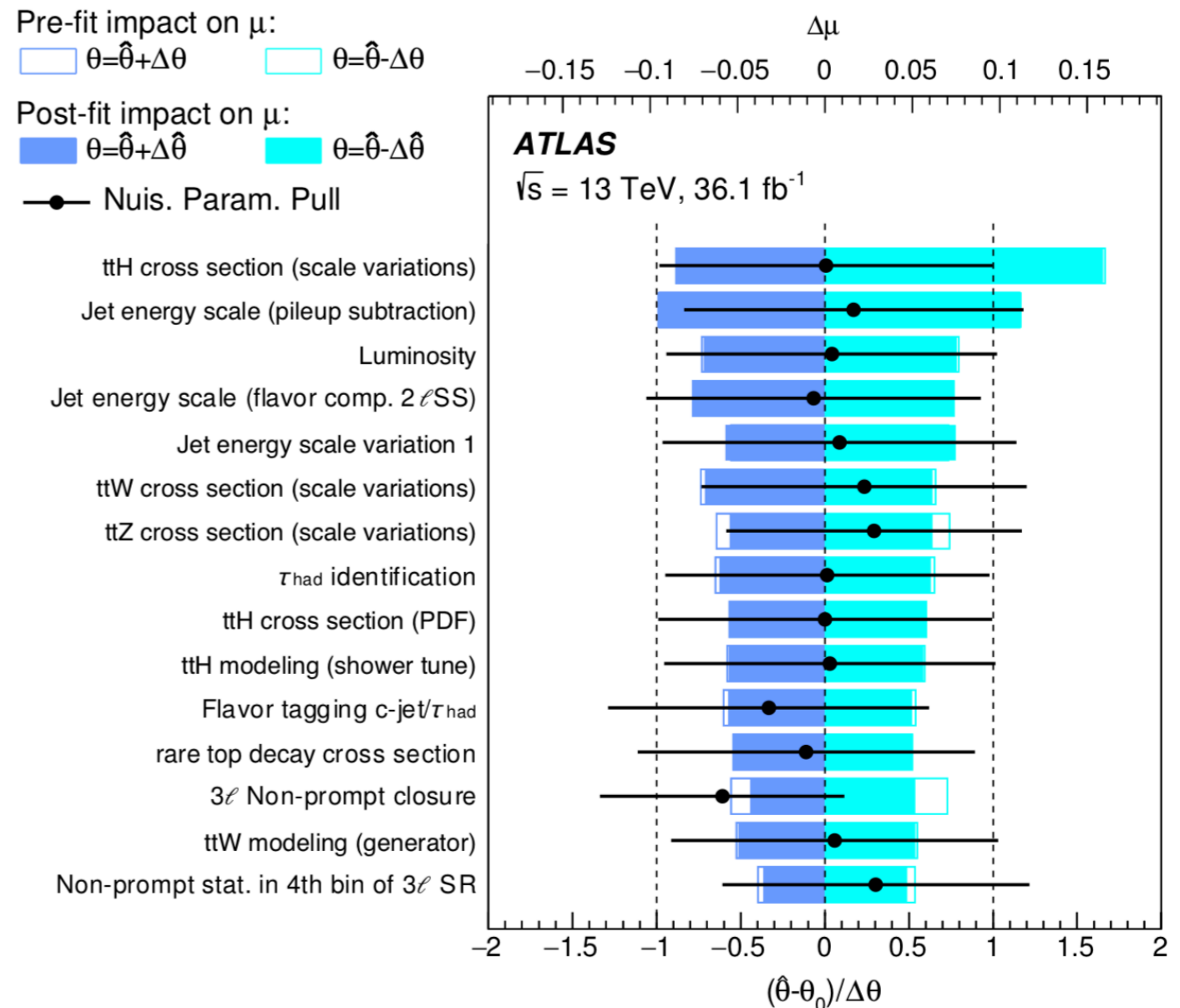
◦ Nominally systematic NPs have:

▶ **Central value = 0** : i.e. the pre-fit expectation

▶ **Uncertainty = 1** : NPs normalized to the value of the systematic

◦ From fit results:

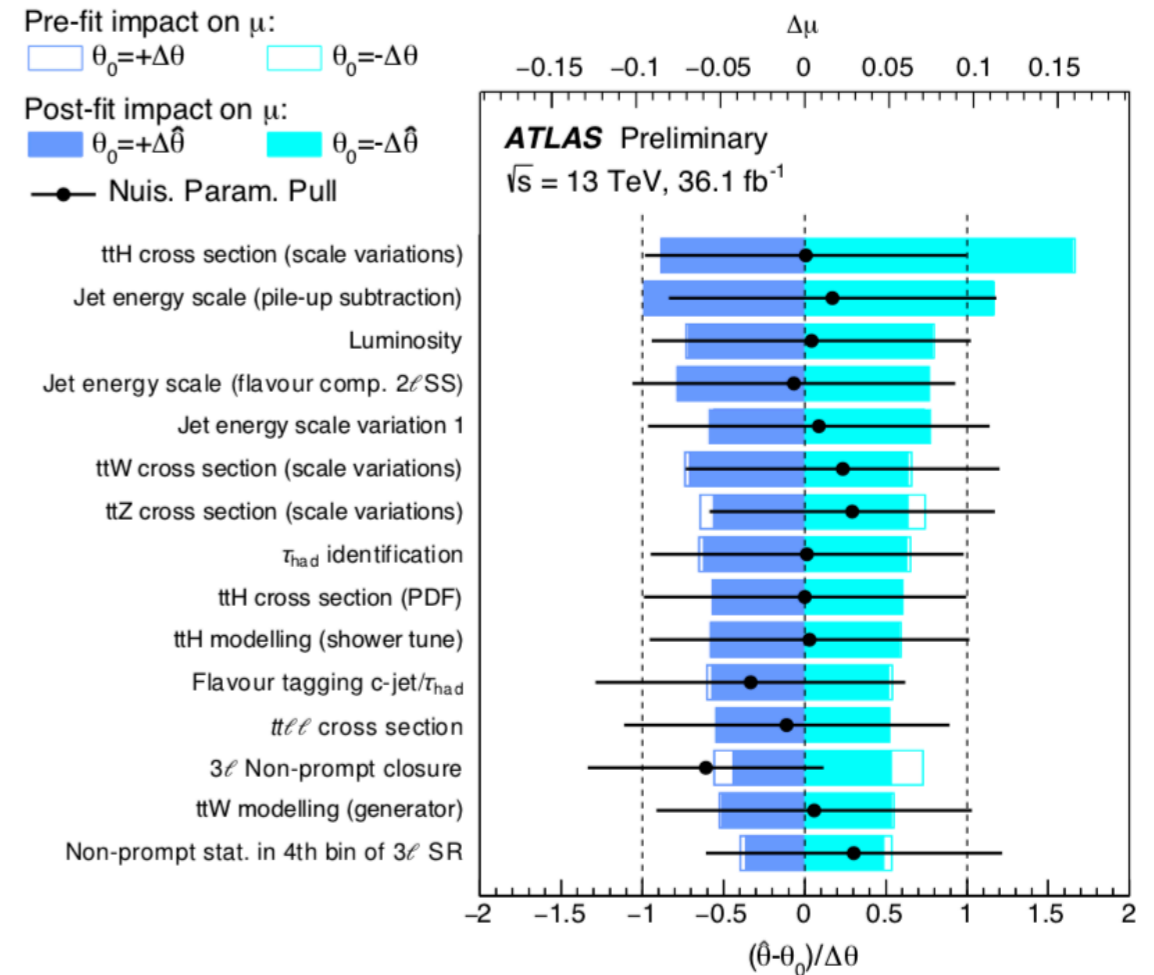
▶ **If central value $\neq 0$** : it indicates the fit is correcting for a biased initial prediction of that parameter



the fit can constrain the estimated uncertainty \rightarrow more statistical sensitivity than the auxiliary measurement used to determine its prior uncertainty

Results

Uncertainty Source	$\Delta\mu$	
$t\bar{t}H$ modelling (cross section)	+0.20	-0.09
Jet energy scale and resolution	+0.18	-0.15
Non-prompt light-lepton estimates	+0.15	-0.13
Jet flavour tagging and τ_{had} identification	+0.11	-0.09
$t\bar{t}W$ modelling	+0.10	-0.09
$t\bar{t}Z$ modelling	+0.08	-0.07
Other background modelling	+0.08	-0.07
Luminosity	+0.08	-0.06
$t\bar{t}H$ modelling (acceptance)	+0.08	-0.04
Fake τ_{had} estimates	+0.07	-0.07
Other experimental uncertainties	+0.05	-0.04
Simulation statistics	+0.04	-0.04
Charge misassignment	+0.01	-0.01
Total systematic uncertainty	+0.39	-0.30



- Most relevant uncertainties on the signal strength:
 - Signal modelling (dominated by scale uncertainties)
 - Jet energy scale and resolution
 - Non-prompt ℓ estimation (with large contribution from limited CR statistics)

MEM

- The matrix element method (MEM) provides a way to calculate the likelihood that an event originates from a given production mechanism → assign probability density value based on theory
- Use **smart phase-space** mappings to align peaks of integrand with coordinate axes (the structure of the integrand can be very complicated: integrand peaks coming from ME and TFs, and there can be many)
 - ▶ The phase-space can be organized in pieces or subsets of variables (blocks)

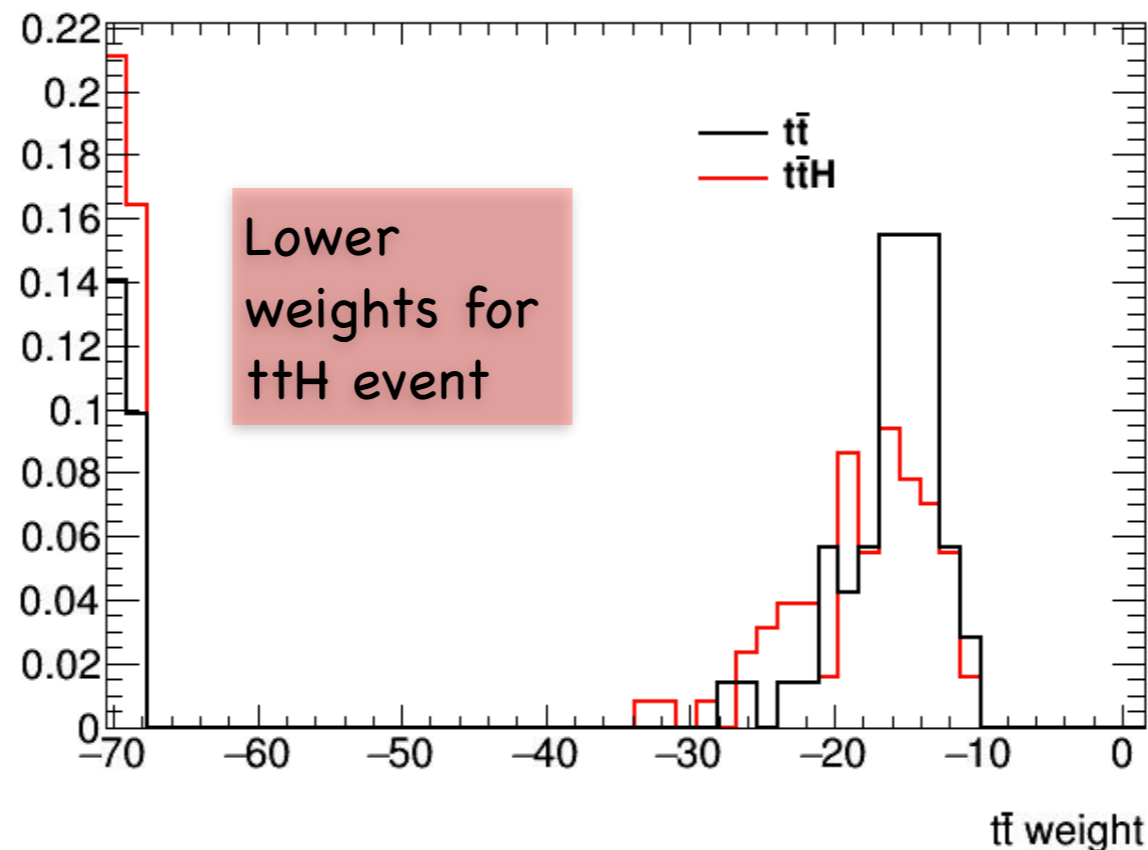
$$w_{i,\alpha}(\Phi') = \frac{1}{\sigma_\alpha} \int d\Phi_\alpha \cdot \delta^4\left(p_1^\mu + p_2^\mu - \sum_{k \geq 2} p_k^\mu\right) \cdot \frac{f(x_1, \mu_F) f(x_2, \mu_F)}{x_1 x_2 S} \cdot \left| \mathcal{M}_\alpha(p_k^\mu) \right|^2 \cdot W(\Phi' | \Phi_\alpha)$$

MEM weight (points to the left side of the equation)
Integration (points to the integral symbol)
Phase-space enforcing 4-momentum conservation (points to the delta function)
Parton distribution function (points to the $f(x, \mu_F)$ terms)
Matrix Element at LO (points to the $|\mathcal{M}_\alpha(p_k^\mu)|^2$ term)
Transfer functions relating parton-level to reconstructed quantities (points to the $W(\Phi' | \Phi_\alpha)$ term)

Interpretation: The MEM weight is the cross section, for a given hypothesis, evaluated at the phase space point of the event, convolved with the transfer functions

Studies on MEM

- MEM can be used to identify the process : Takes as input a set of kinematic observables associated to the diagram and calculates the weight for each event, can be calculated;
 - for all permutations of the selected objects or,
 - for the reconstructed particles (eg. by BDT).



Conclusion

Evidence

Analysis	Integrated luminosity [fb^{-1}]	$t\bar{t}H$ cross section [fb]	Obs. sign.	Exp. sign.
$H \rightarrow \gamma\gamma$	79.8	710^{+210}_{-190} (stat.) $^{+120}_{-90}$ (syst.)	4.1σ	3.7σ
$H \rightarrow \text{multilepton}$	36.1	790 ± 150 (stat.) $^{+150}_{-140}$ (syst.)	4.1σ	2.8σ
$H \rightarrow b\bar{b}$	36.1	400^{+150}_{-140} (stat.) ± 270 (syst.)	1.4σ	1.6σ
$H \rightarrow ZZ^* \rightarrow 4\ell$	79.8	<900 (68% CL)	0σ	1.2σ
Combined (13 TeV)	36.1–79.8	670 ± 90 (stat.) $^{+110}_{-100}$ (syst.)	5.8σ	4.9σ
Combined (7, 8, 13 TeV)	4.5, 20.3, 36.1–79.8	–	6.3σ	5.1σ

Observation

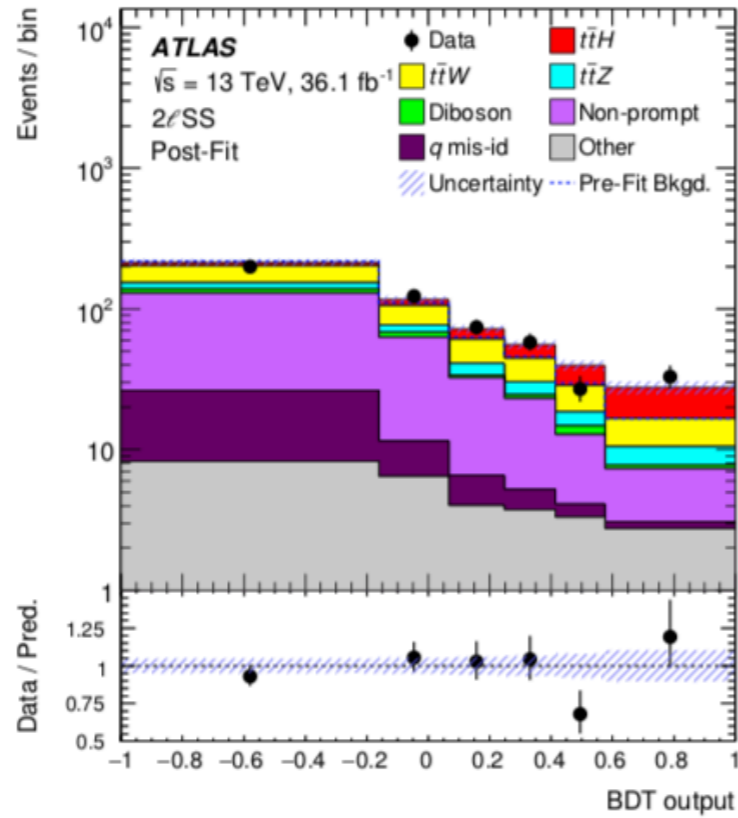
- This year, the studies are on going to improve the $t\bar{t}H$ -Multilepton results
- Paper with 80/fb results for $t\bar{t}H$ -ML

Backup

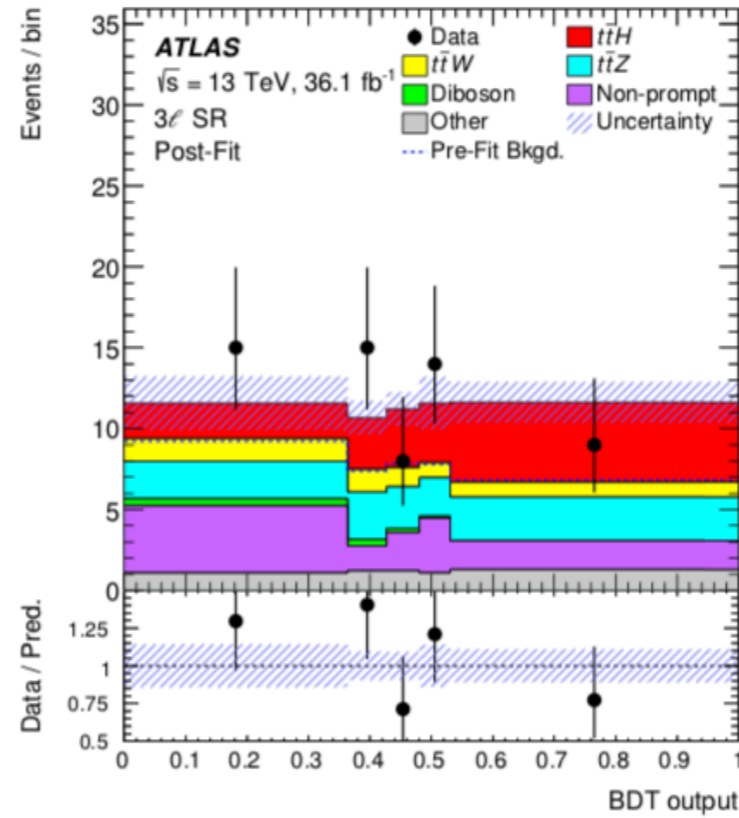
Backup

Process	Event generator	ME order	Parton Shower	PDF	Tune
$t\bar{t}H$	MG5_AMC (MG5_AMC)	NLO (NLO)	PYTHIA 8 (HERWIG++)	NNPDF 3.0 NLO [70] (CT10 [71])	A14 (UE-EE-5)
$tHqb$	MG5_AMC	LO	PYTHIA 8	CT10	A14
tHW	MG5_AMC	NLO	HERWIG++	CT10	UE-EE-5
$t\bar{t}W$	MG5_AMC (SHERPA 2.1.1)	NLO (LO multileg)	PYTHIA 8 (SHERPA)	NNPDF 3.0 NLO (NNPDF 3.0 NLO)	A14 (SHERPA default)
$t\bar{t}(Z/\gamma^* \rightarrow ll)$	MG5_AMC (SHERPA 2.1.1)	NLO (LO multileg)	PYTHIA 8 (SHERPA)	NNPDF 3.0 NLO (NNPDF 3.0 NLO)	A14 (SHERPA default)
tZ	MG5_AMC	LO	PYTHIA 6	CTEQ6L1	Perugia2012
tWZ	MG5_AMC	NLO	PYTHIA 8	NNPDF 2.3 LO	A14
$t\bar{t}t, t\bar{t}\bar{t}$	MG5_AMC	LO	PYTHIA 8	NNPDF 2.3 LO	A14
$t\bar{t}W^+W^-$	MG5_AMC	LO	PYTHIA 8	NNPDF 2.3 LO	A14
$t\bar{t}$	POWHEG-BOX v2 [72]	NLO	PYTHIA 8	NNPDF 3.0 NLO	A14
$t\bar{t}\gamma$	MG5_AMC	LO	PYTHIA 8	NNPDF 2.3 LO	A14
s -, t -channel, Wt single top	POWHEG-BOX v1 [73–75]	NLO	PYTHIA 6	CT10	Perugia2012
$VV(\rightarrow llXX),$ $qqVV, VVV$	SHERPA 2.1.1	MEPS NLO	SHERPA	CT10	SHERPA default
$Z \rightarrow l^+l^-$	SHERPA 2.2.1	MEPS NLO	SHERPA	NNPDF 3.0 NLO	SHERPA default

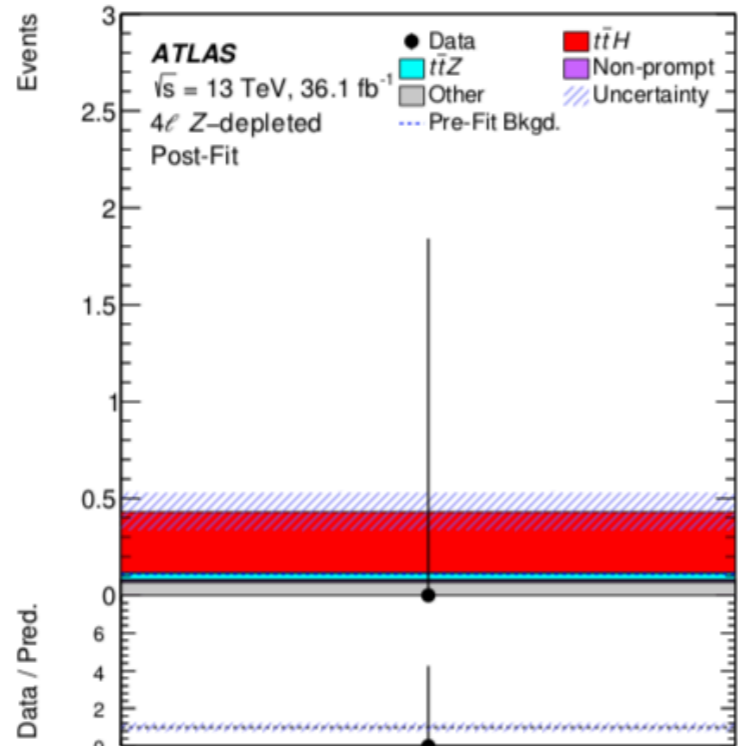
Backup



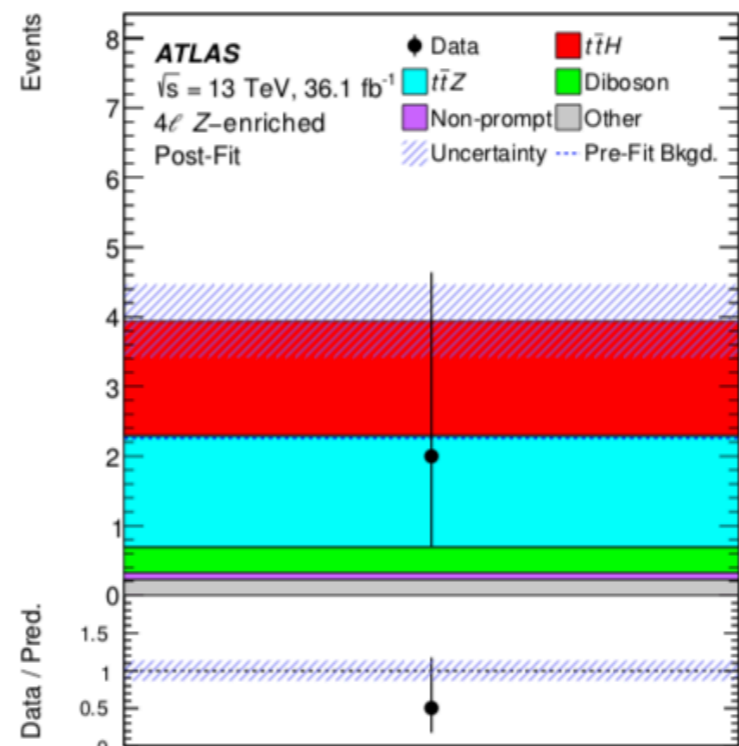
(a)



(b)

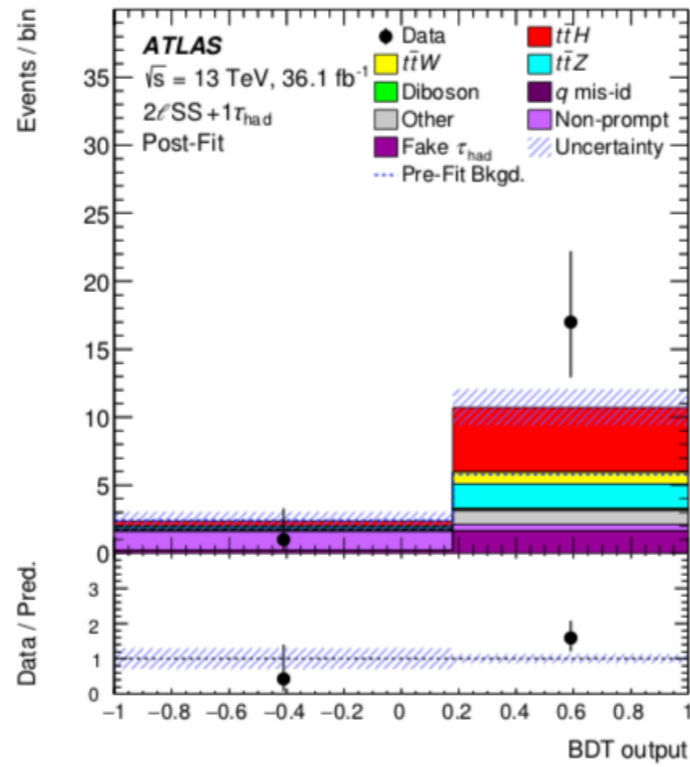


(c)

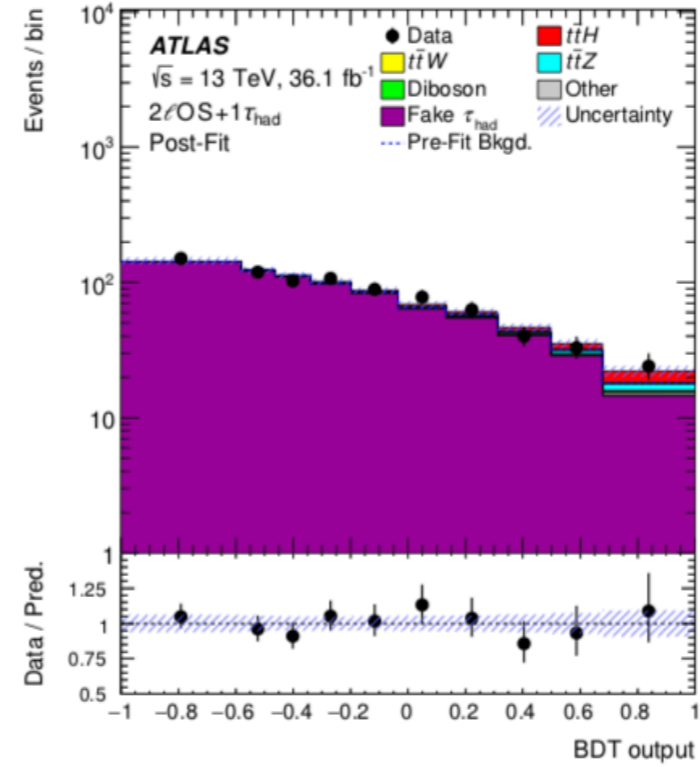


(d)

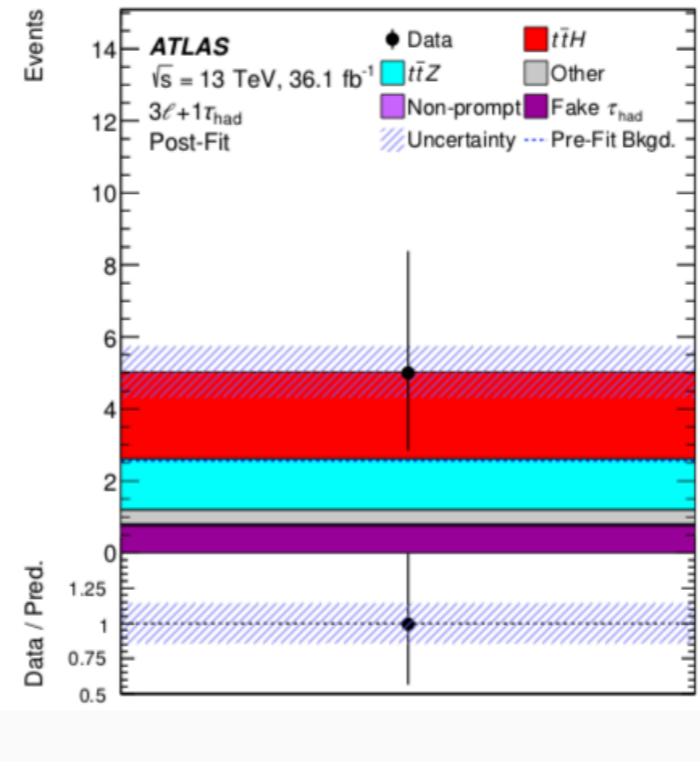
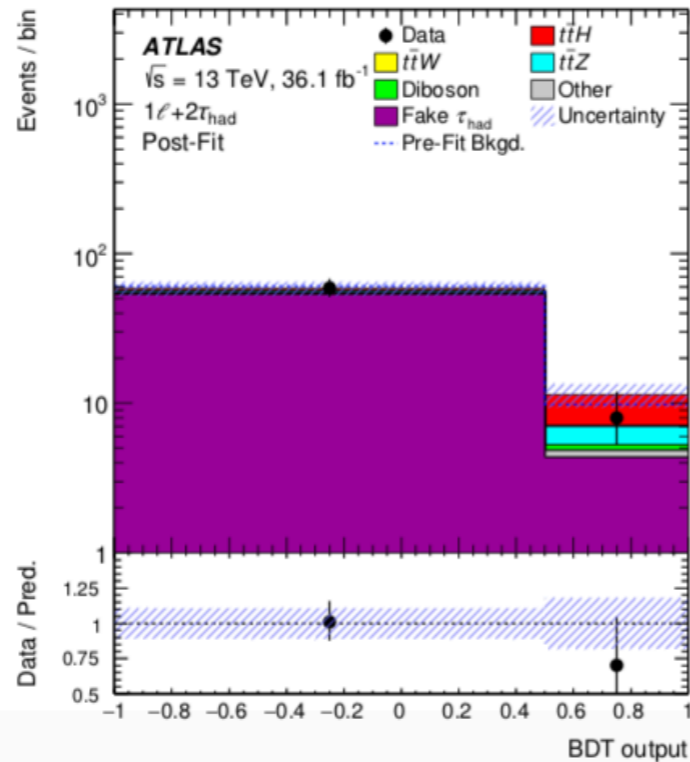
Backup



(a)



(b)



Backup

Channel	Selection criteria
Common	$N_{\text{jets}} \geq 2$ and $N_{b\text{-jets}} \geq 1$
$2\ell\text{SS}$	Two very tight light leptons with $p_T > 20$ GeV Same-charge light leptons Zero medium τ_{had} candidates $N_{\text{jets}} \geq 4$ and $N_{b\text{-jets}} < 3$
3ℓ	Three light leptons with $p_T > 10$ GeV; sum of light-lepton charges ± 1 Two same-charge leptons must be very tight and have $p_T > 15$ GeV The opposite-charge lepton must be loose, isolated and pass the non-prompt BDT Zero medium τ_{had} candidates $m(\ell^+\ell^-) > 12$ GeV and $ m(\ell^+\ell^-) - 91.2 \text{ GeV} > 10$ GeV for all SFOC pairs $ m(3\ell) - 91.2 \text{ GeV} > 10$ GeV
4ℓ	Four light leptons; sum of light-lepton charges 0 Third and fourth leading leptons must be tight $m(\ell^+\ell^-) > 12$ GeV and $ m(\ell^+\ell^-) - 91.2 \text{ GeV} > 10$ GeV for all SFOC pairs $ m(4\ell) - 125 \text{ GeV} > 5$ GeV Split 2 categories: Z-depleted (0 SFOC pairs) and Z-enriched (2 or 4 SFOC pairs)
$1\ell+2\tau_{\text{had}}$	One tight light lepton with $p_T > 27$ GeV Two medium τ_{had} candidates of opposite charge, at least one being tight $N_{\text{jets}} \geq 3$
$2\ell\text{SS}+1\tau_{\text{had}}$	Two very tight light leptons with $p_T > 15$ GeV Same-charge light leptons One medium τ_{had} candidate, with charge opposite to that of the light leptons $N_{\text{jets}} \geq 4$ $ m(ee) - 91.2 \text{ GeV} > 10$ GeV for ee events
$2\ell\text{OS}+1\tau_{\text{had}}$	Two loose and isolated light leptons with $p_T > 25, 15$ GeV One medium τ_{had} candidate Opposite-charge light leptons One medium τ_{had} candidate $m(\ell^+\ell^-) > 12$ GeV and $ m(\ell^+\ell^-) - 91.2 \text{ GeV} > 10$ GeV for the SFOC pair $N_{\text{jets}} \geq 3$
$3\ell+1\tau_{\text{had}}$	3ℓ selection, except: One medium τ_{had} candidate, with charge opposite to the total charge of the light leptons The two same-charge light leptons must be tight and have $p_T > 10$ GeV The opposite-charge light lepton must be loose and isolated

Backup

Electrons		
	Loose (baseline)	Tight
Minimum p_T	10 GeV	—
$ \eta $	≤ 1.37	—
$ d_0^{sig} $	5	—
$ z_0 \sin \theta $	0.5 mm	—
Isolation	Loose	FixedCutTight
Electron ID	LooseLH	TightLH
Muons		
	Loose (baseline)	Tight
Minimum p_T	10 GeV	—
$ \eta $	≤ 2.5	—
$ d_0^{sig} $	3	—
$ z_0 \sin \theta $	0.5 mm	—
Isolation	Loose	FixedCutTightTrackOnly
Quality	Loose	—

Table 97: Definition of leptons for the efficiency measurement.

Backup

	Real CR	Fake CR
Selection	2,3,4 jets ≥ 1 b-tagged jet 2 LL OS leptons ≥ 1 trigger-matched lepton $\min(p_T^\ell) \geq 10$ GeV OF leptons — —	2,3,4 jets ≥ 1 b-tagged jet 2 LL SS leptons ≥ 1 trigger-matched lepton $\min(p_T^\ell) \geq 10$ GeV $\mu\mu$ for ϵ_μ , inclusive flavour for ϵ_e $ m(\ell\ell) - m_Z \geq 7.5$ GeV (for ee) $m(\ell\ell) \geq 20$ GeV (for same flavour)

Table 94: Definition of the control regions used for measuring the real and fake efficiencies.

Backup

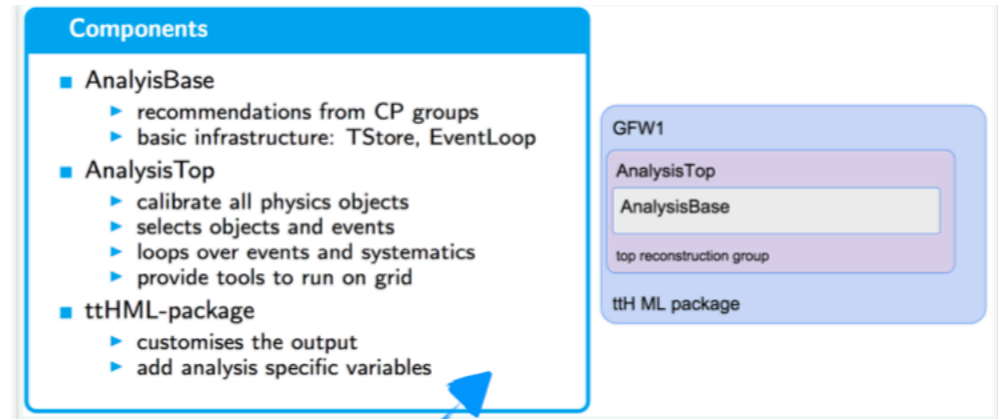
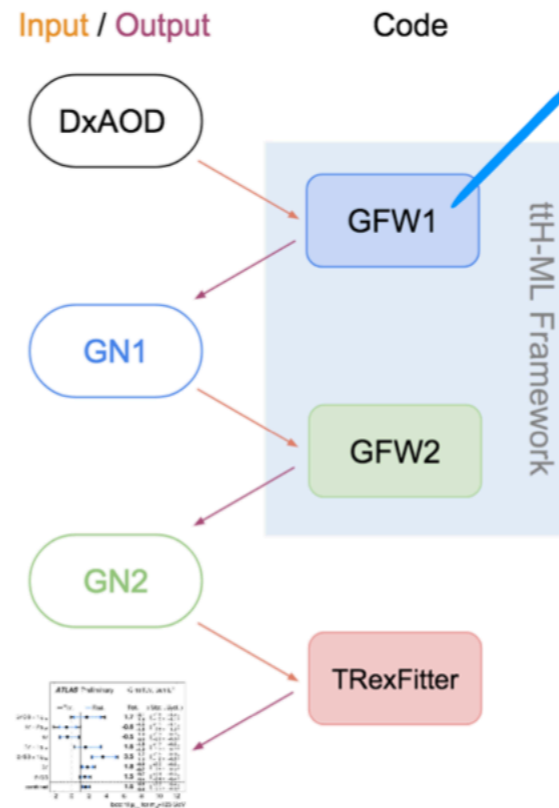
- * ttH-ML analysis workflow = two main group frameworks + statistical tool framework
- * Other FW used for:
 - Tau fake estimates [TBC]
 - Matrix Method efficiencies calculation

The goal of the framework

- get sample with calibrated objects
 - ▶ perform data-driven of background estimations
 - ▶ train MVA optimisations
- apply selection criteria on data and MC
 - ▶ inputs to statistical interpretations

GroupFrameWork

- GFW1:
 - ▶ Processes DxAODs, create large ntuples: GN1 - few TB
- GFW2:
 - ▶ Produce fit input ntuples: GN2 - few GB



Backup

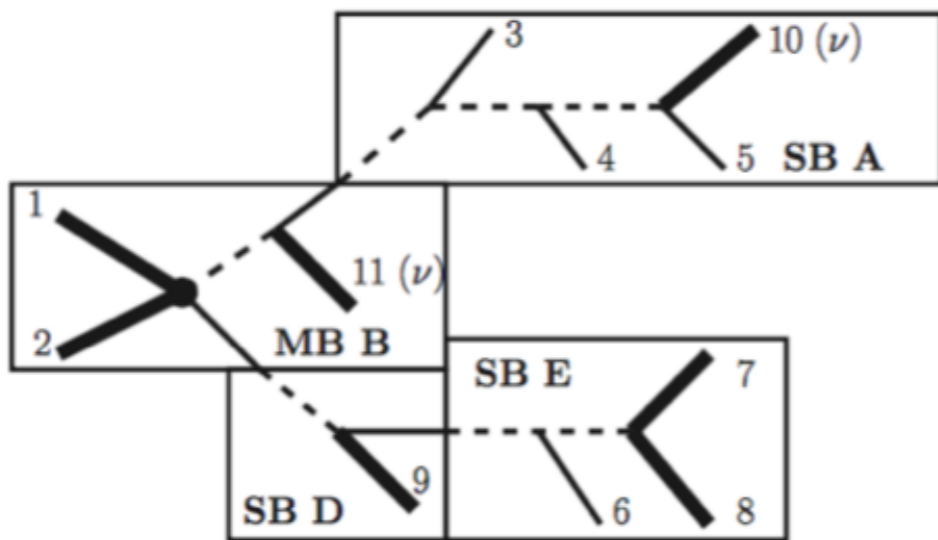
Systematic uncertainty	Type	Components
Luminosity	N	1
Pileup reweighting	SN	1
Physics Objects		
Electron	SN	6
Muon	SN	15
τ_{had}	SN	10
Jet energy scale and resolution	SN	28
Jet vertex fraction	SN	1
Jet flavor tagging	SN	126
$E_{\text{T}}^{\text{miss}}$	SN	3
Total (Experimental)	–	191
Data-driven non-prompt/fake leptons and charge misassignment		
Control region statistics	SN	38
Light-lepton efficiencies	SN	22
Non-prompt light-lepton estimates: non-closure	N	5
γ -conversion fraction	N	5
Fake τ_{had} estimates	N/SN	12
Electron charge misassignment	SN	1
Total (Data-driven reducible background)	–	83

Backup

Total (Data-driven reducible background)	–	83
$t\bar{t}H$ modeling		
Cross section	N	2
Renormalization and factorization scales	S	3
Parton shower and hadronization model	SN	1
Higgs boson branching fraction	N	4
Shower tune	SN	1
$t\bar{t}W$ modeling		
Cross section	N	2
Renormalization and factorization scales	S	3
Matrix-element MC event generator	SN	1
Shower tune	SN	1
$t\bar{t}Z$ modeling		
Cross section	N	2
Renormalization and factorization scales	S	3
Matrix-element MC event generator	SN	1
Shower tune	SN	1
Other background modeling		
Cross section	N	15
Shower tune	SN	1
Total (Signal and background modeling)	–	41
Total (Overall)	–	315

Backup

- The method consists in the calculation of an integral, where:
 - ▶ PDF → available from several collaborations (eg. LHAPDF)
 - ▶ Matrix Element → from MC (eg. MadGraph)
 - ▶ Transfer Functions → can be parametrized from MC
 - ▶ Once you have all the terms, integrate! (eg. VEGAS, **Cuba**)
- Use **smart phase-space** mappings to align peaks of integrand with coordinate axes (the structure of the integrand can be very complicated: integrand peaks coming from ME and TFs, and there can be many)
 - ▶ The phase-space can be organized in pieces or subsets of variables (blocks)



$p_1 \rightarrow p_2 p_3 \iff dE_2 d\theta_2 d\phi_2 dE_3 d\theta_3 d\phi_3$, where particle 3 is a neutrino

Apply change of variables to align the ME propagator:

$$\implies dE_2 d\theta_2 d\phi_2 ds_1 d\theta_3 d\phi_3 \times jac.$$

\implies Propagator for p_1 aligned with grid!

Standard phase-space parametrization:

$$d\Phi(y) \propto \prod_i \frac{|p_i|^2 d|p_i| d\phi_i \sin\theta_i d\theta_i}{2E_i} \delta^4(P_{in} - P_{fin})$$